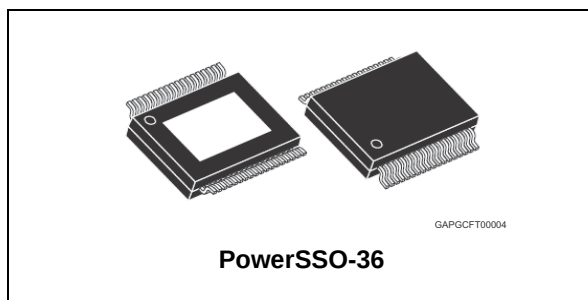


## Integrated solenoid driver for automotive applications

Datasheet - production data



### Features

- Automotive qualified
- Excitation switch  $S_1 = 60\text{ m}\Omega$
- Recirculation switch  $S_2 = 60\text{ m}\Omega$
- CMOS compatible inputs
- Load current up to 14 A
- Integrated clamp structure
  - Switch  $S_1$  clamp voltage = 45 V (minimum)
- Current sense amplifier with internal sense resistor
- $S_1$  switch PWM operation above 10 KHz
- I<sup>2</sup>C standard interface for mode control and enhanced diagnostic
- Diagnostic output:
  - Open drain fault detection
  - Flag of clamp activation at the end of injection cycle
- Input for voltage monitoring and feedback
- Thermal shutdown and warning
- Overcurrent shutdown and diagnostic
- Undervoltage and overvoltage detection
- Open-load detection

### Description

The L99SD01-E is a device intended for driving inductive loads such as Compressed Natural Gas (CNG) injectors.

The inputs are CMOS-compatible. The diagnostic outputs CLAMP\_FLAG and FAULT provide an indication of demagnetization mode and fault conditions, respectively.

The integrated standard serial interface (I<sup>2</sup>C) allows to digitally set peak and hold current values and other injection parameters. It also provides detailed diagnostic information. The device should work with pre-programmed peak and hold current values when values are not set by external micro. All injection parameters can be changed during operating conditions and taken into account at the first injection rising edge after the end of communication. Diagnostic information is available in case of overcurrent, overtemperature, overvoltage and open-load.

Table 1. Device summary

| Package     | Order codes |               |
|-------------|-------------|---------------|
|             | Tube        | Tape and reel |
| PowerSSO-36 | L99SD01-E   | L99SD01TR-E   |

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# 1 Block diagram and pin description

Figure 1. Block diagram

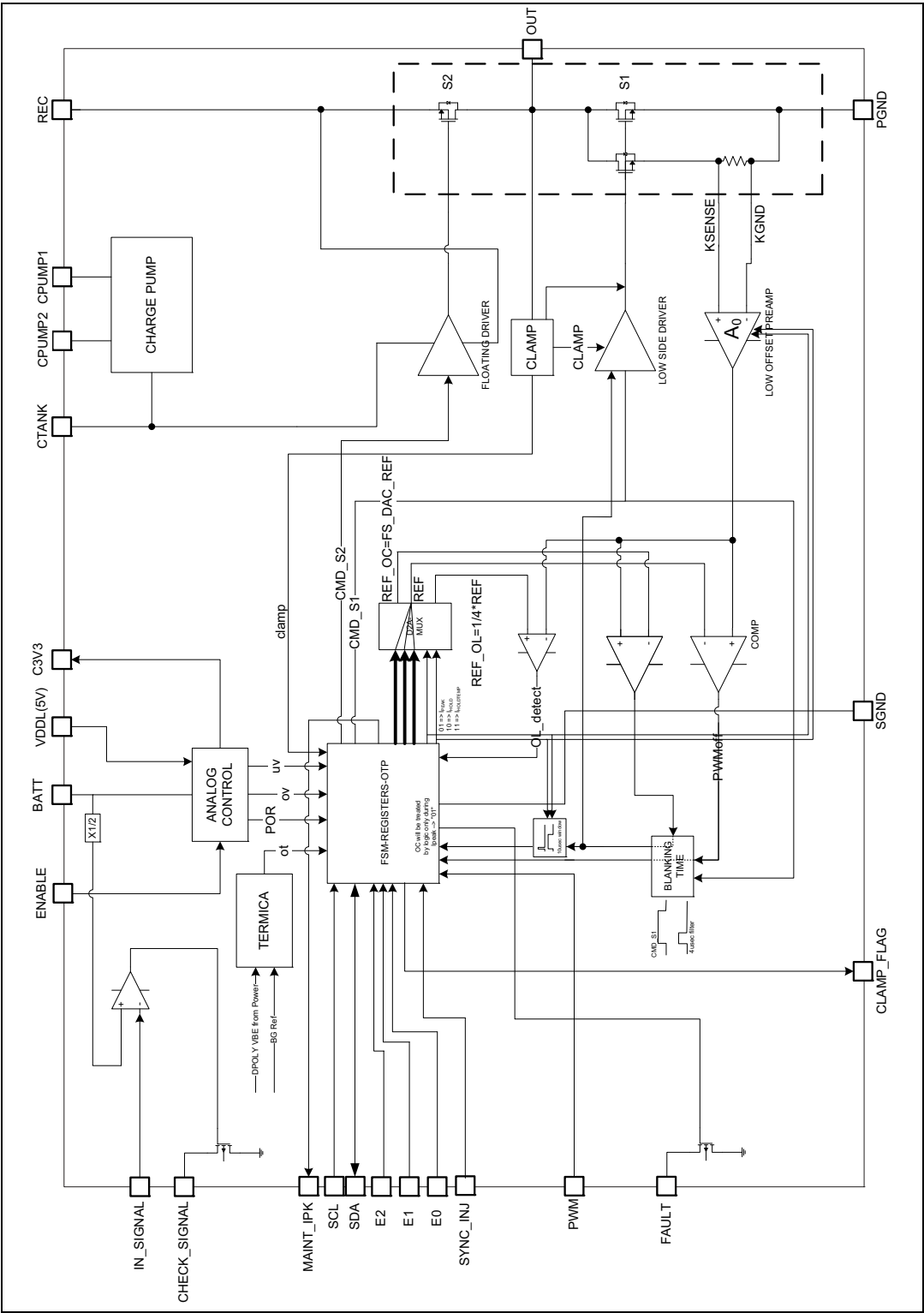


Table 2. Pin description

| Pin number | Pin name     | Description                                                                                                                                                         |
|------------|--------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1          | OTP_15V      | Power supply for OTP test purposes. Not connected.                                                                                                                  |
| 2          | IN_SIGNAL    | This pin is used to acquire (through an external resistor) the signal coming from the Main ECU                                                                      |
| 3          | CHECK_SIGNAL | The voltage on the "IN_SIGNAL" pin is compared with $V_{BATT}/2$ :<br>IF IN_SIGNAL > Vbatt/2 then CHECK_SIGNAL = H<br>IF IN_SIGNAL <= Vbatt/2 then CHECK_SIGNAL = L |
| 4          | MAINT_IPK    | Diagnostic pin going high when device is regulating Ipeak current value                                                                                             |
| 5          | CLAMP_FLAG   | Reporting the CLAMP intervention and the end of injection cycle                                                                                                     |
| 6          | SDA          | I <sup>2</sup> C serial interface data line                                                                                                                         |
| 7          | SCL          | I <sup>2</sup> C serial interface clock line (100 kHz)                                                                                                              |
| 8          | FAULT        | The FAULT pin is pulled low whenever a fault condition is detected.                                                                                                 |
| 9          | PWM          | External PWM clock                                                                                                                                                  |
| 10         | SYNC_INJ     | It is used for injection synchronization and to set the single injection duration.                                                                                  |
| 11         | ENABLE       | This pin is used to enable/disable the device. When low, device enters standby low consumption mode                                                                 |
| 12         | TEST         | Test activation. Not connected.                                                                                                                                     |
| 13         | TEST_OUT3    | Pin for test purposes. Not connected                                                                                                                                |
| 14         | SGND         | Signal ground pin. Do not connect to ground module. Use for local capacitor connection                                                                              |
| 15-18      | PGND         | Power ground pin                                                                                                                                                    |
| 19-22      | REC          | Recirculation path – the external recirculation diode is connected between this pin and battery.                                                                    |
| 23         | TEST_OUT2    | Pin for test purposes. Not connected                                                                                                                                |
| 24         | TEST_OUT1    | Pin for test purposes. Not connected                                                                                                                                |
| 25         | BATT         | Power supply voltage                                                                                                                                                |
| 26         | CPUMP1       | Charge pump pin for external capacitor connection                                                                                                                   |
| 27         | CPUMP2       | Charge pump pin for external capacitor connection                                                                                                                   |
| 28         | CTANK        | Supply voltage for high side driver                                                                                                                                 |
| 29         | VDDL         | 5 V external supply voltage                                                                                                                                         |
| 30         | C3V3         | 3.3 V supply pin for external capacitor connection                                                                                                                  |
| 31         | SGND         | Signal ground pin. Do not connect to ground module. Use for local capacitor connection                                                                              |
| 32         | E0           | Address pin externally hard wired to ground or VDDL to address till 8 devices in parallel                                                                           |
| 33         | E1           | Address pin externally hard wired to ground or VDDL to address till 8 devices in parallel                                                                           |

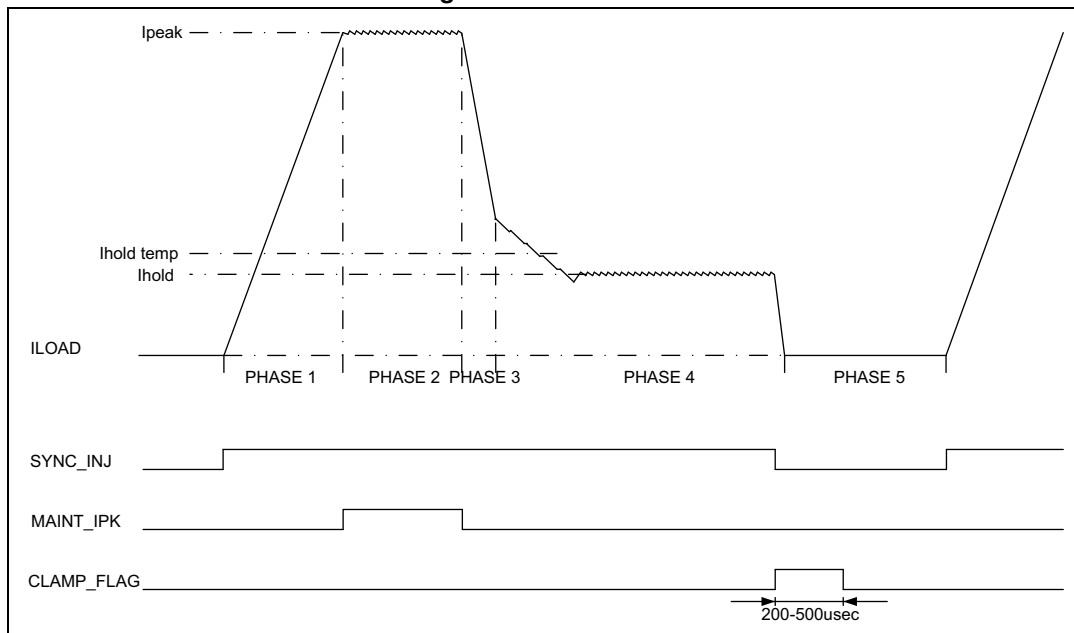
Table 2. Pin description (continued)

| Pin number | Pin name | Description                                                                               |
|------------|----------|-------------------------------------------------------------------------------------------|
| 34         | E2       | Address pin externally hard wired to ground or VDDL to address till 8 devices in parallel |
| 35         | SGND     | Signal ground pin. Do not connect to ground module. Use for local capacitor connection    |
| 36         | OTP_0V   | Power ground for OTP test purposes. Not connect                                           |
| Tab        | OUT      | Excitation path – the injector is connected between battery and this pin                  |

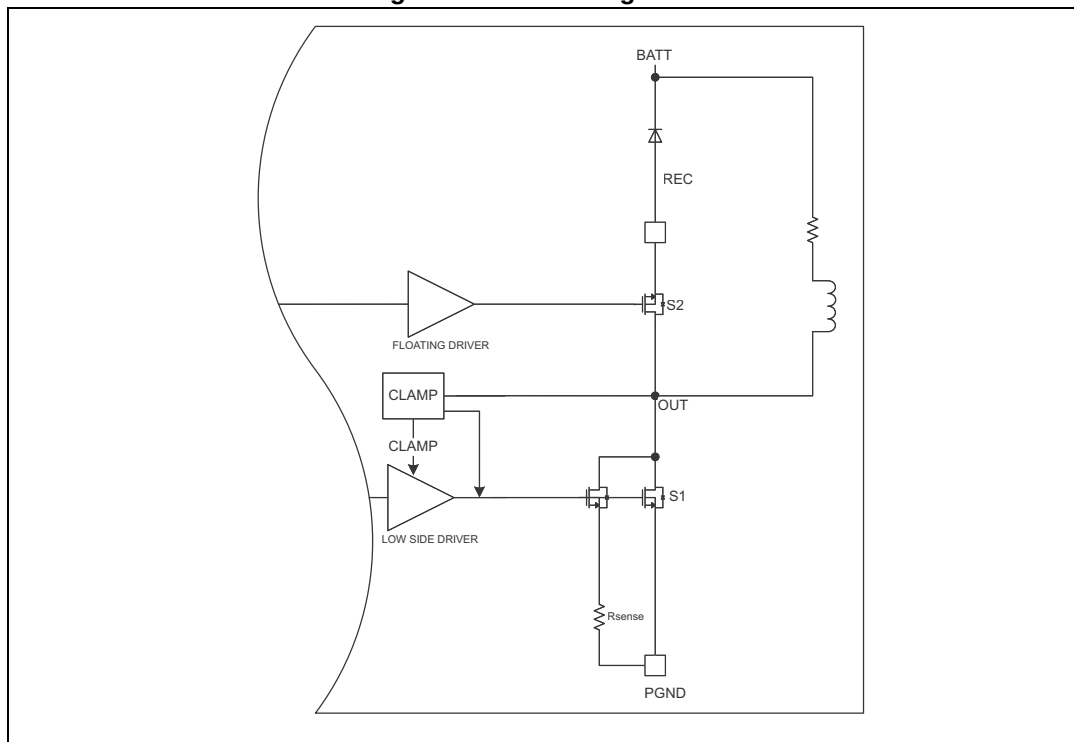
## 2 Injection cycle description

[Figure 2](#) includes the main waveforms showing a typical injection cycle while [Figure 3](#) shows typical load connection and recirculation diode.

**Figure 2. Waveforms**



**Figure 3. Load configuration**



## 2.1 Phase 1

Injection phase starts by closing  $S_1$  switch when there is a rising edge of SYNC\_INJ signal. During this phase current on injector rises till an  $I_{PEAK}$  value set in the register A. If current doesn't reach  $I_{PEAK}$  value within a maximum time fixed in register H, the device status switches from phase 1 to phase 2.

## 2.2 Phase 2

If current hasn't still reached  $I_{PEAK}$  value  $S_1$  switch continues to be ON and current continues to flow through load during all phase 2 whose length is set in register B. As soon as current reaches  $I_{PEAK}$  value it will be regulated in PWM mode at this value. PWM frequency is fixed by external clock via PWM pin.

Current is controlled by shutting-down  $S_1$  when current reaches  $I_{PEAK}$  value. During the remaining period injector current is re-circulating through  $S_2$  switch which should be always closed during phase 1 and phase 2. We speak about slow-recirculation during this phase.

Pin MAINT\_IPK should be kept high (5 V) when current has reached and is regulated around  $I_{PEAK}$  value.

## 2.3 Phase 3

This is the temporary phase to go from  $I_{PEAK}$  to  $I_{HOLD}$  value. During this phase  $S_1$  is open. Register C sets the time length of this phase. Register D sets the recirculation mode:

- Slow recirculation:  $S_2$  closed.
- Fast recirculation:  $S_2$  open and clamp on  $S_1$  activated.

A particular case is when at the end of phase 2 current has not reached  $I_{PEAK}$  value yet. In this case device will go to phase 3 in slow recirculation mode whatever the value set in register D.

## 2.4 Phase 4

During this phase current is controlled to  $I_{HOLD}$  value. During this phase  $S_2$  is always closed. Register E sets  $I_{HOLD}$  current value. Current is controlled by shutting-down  $S_1$  when current reaches  $I_{HOLD}$  value. Recirculation is slow because  $S_2$  is closed during this phase.

PWM clock signal is given externally on pin PWM.

This phase starts at the end of phase 3 when current on injector has slowed down but not below the holding value. For this reason at the beginning of this phase PWM duty cycle will be fixed by the minimum turn-on time of regulation loop, till the current reaches  $I_{HOLD}$  value.

This phase lasts till the end of injection given by the falling edge of SYNC\_INJ signal. Shutting of injector is done by turning off  $S_1$  and  $S_2$ . Fast recirculation happens through  $S_1$  by clamp activation. CLAMP\_FLAG is set to high value (5 V) during 350  $\mu$ sec minimum. To minimize the current ripple during the passage from phase 3 to phase 4, a temporary hold value could be used for some PWM cycles. Register F sets this temporary hold current value, whilst Register G sets time length.

## 2.5 Phase 5

System is waiting for next injection cycle. No current is flowing through injector. Switches  $S_1$  and  $S_2$  are open.

End of injection cycle could happen everywhere during injection cycle. So device should sustain fast recirculation even during phase 2 with high current values.

If the time duration of one phase is set to zero then the corresponding phase should be skipped and device must enter the following phase.

All registers have pre-programmed values hard coded in the device. So device can operate as it is without needing of a first programming phase (for typical application). In all other applications first register writing is done automatically at the beginning of communication. All registers could be modified during the operating phase. Modified values are activated at the beginning of the first injection cycle following the end of the serial communication.

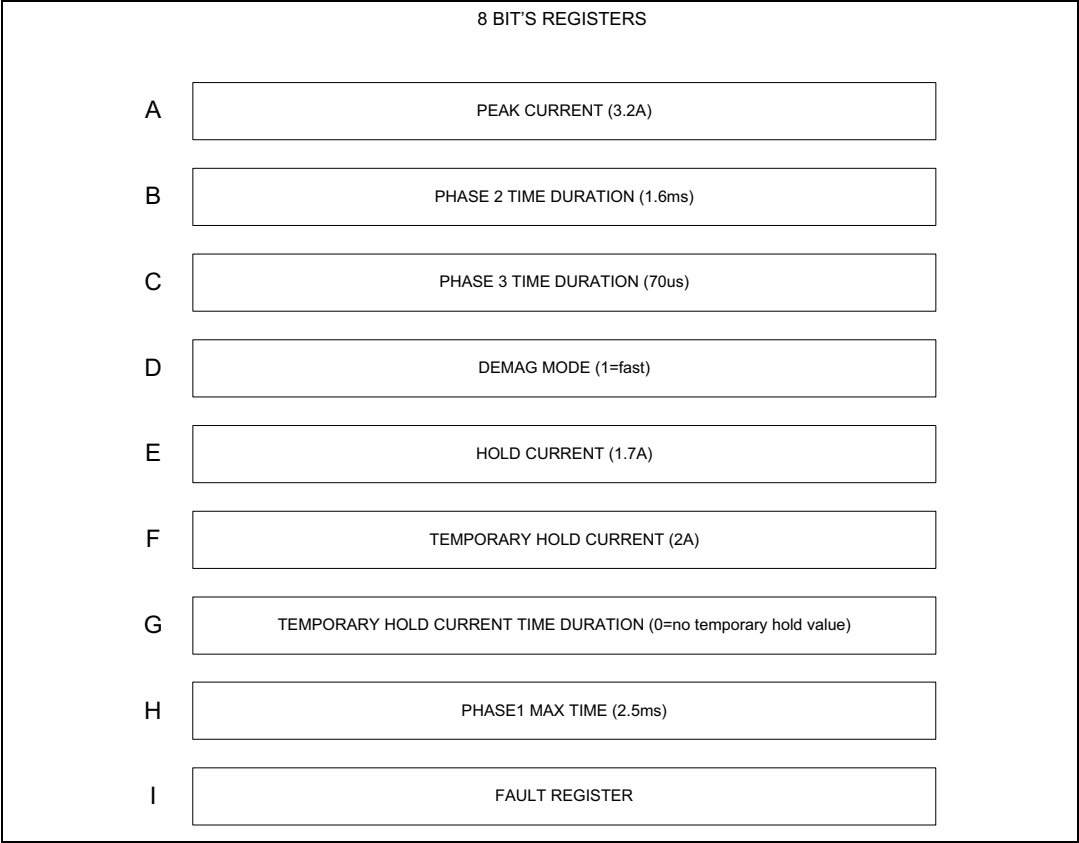
Synchronization event is the rising edge of SYNC\_INJ signal. In reset state all registers are cleared.

Enable pin allows device to enter standby mode with very low current consumption. Enable signal can be supplied directly by microcontroller.

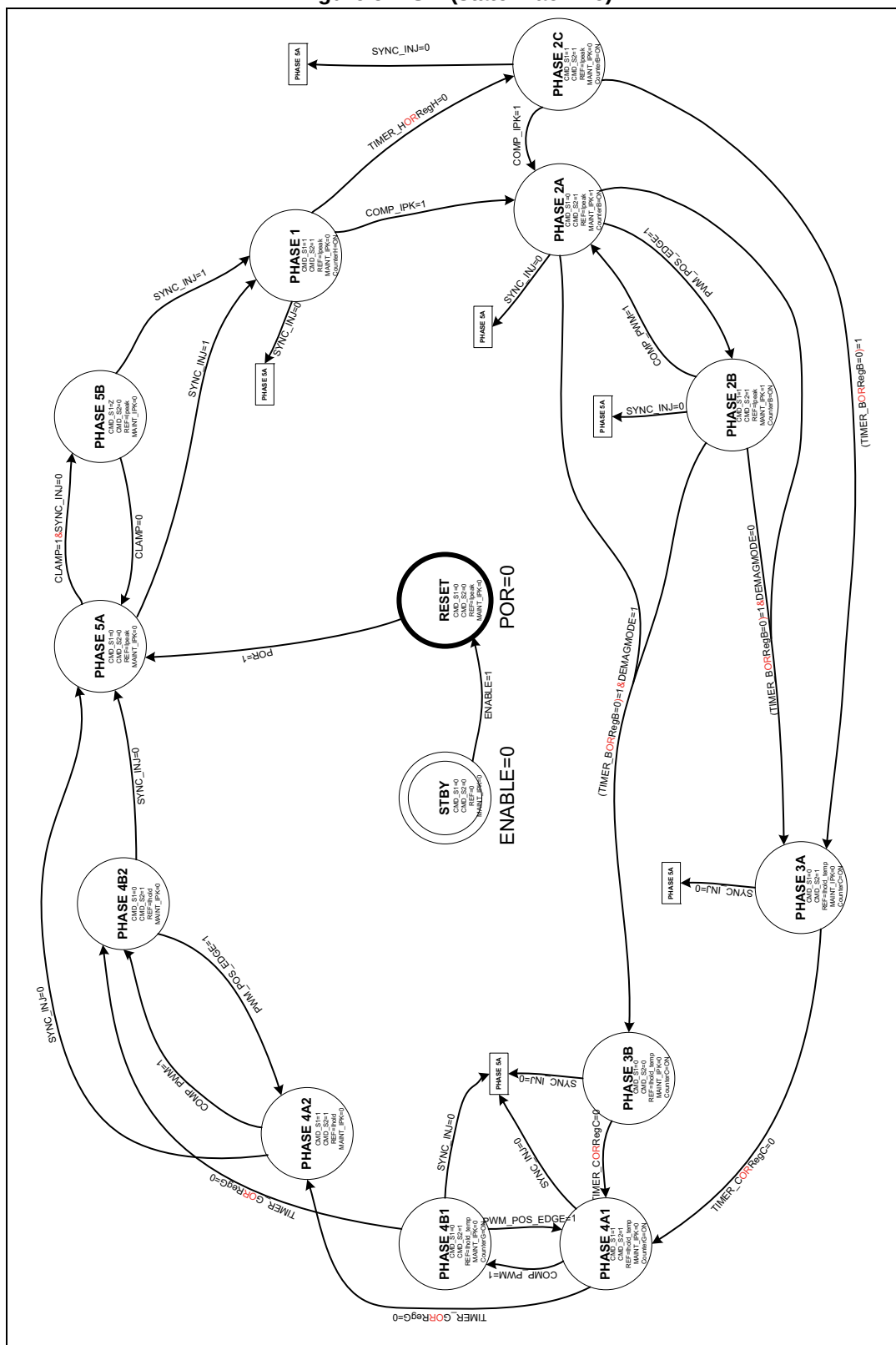
Typical applications include 4 to 8 injectors which are driven via a microcontroller through a serial interface (I<sup>2</sup>C). Each device is recognizable by a unique hard wired address code. Three pins are devoted to code up to 8 device addresses.

Each communication between microcontroller and each device is closed by an acknowledgment message. If this message does not arrive it means that something is not working in communication between microcontroller and L99SD01-E.

Figure 4. Registers (default values)



**Figure 5. FSM (state machine)**



### 3 Diagnostic

Device is auto-protected against some failures and is able to send the information fault to microcontroller via FAULT pin and serial communication line. The following table resumes all the fault conditions detected by the device and the corresponding device behavior.

**Table 3. Diagnostic fault**

| Fault condition                       | Device behavior                                                                                                                                                                                                                                                                                                                                                                                                                  |
|---------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| THERMAL SHUTDOWN                      | Shutdown S <sub>1</sub> with slow recirculation (S <sub>2</sub> on). Fault pin low and fault register set.<br>Device restarts when temperature slows down the reset value. Fault register reset by microcontroller.                                                                                                                                                                                                              |
| THERMAL WARNING                       | Normal mode. Fault register set. Fault register reset by microcontroller. No action on Fault pin.                                                                                                                                                                                                                                                                                                                                |
| UNDERVOLTAGE                          | Normal mode. Fault pin low and fault register set. Fault register reset by microcontroller.                                                                                                                                                                                                                                                                                                                                      |
| OVERVOLTAGE                           | Normal mode. Fault pin low and fault register set. Fault register reset by microcontroller.                                                                                                                                                                                                                                                                                                                                      |
| OUTPUT SHORTED TO BATT <sup>(1)</sup> | Shut down immediately after minimum turn on time. Fault pin low and fault register set. To avoid false overcurrent detections, fault is latched in register only if happens during phase 1 or 2.<br>In case of resistive short circuit, at the beginning of injection cycle current through load rises too fast and this will set as a short fault.<br>Device couldn't restart until fault register is reset by microcontroller. |
| OPEN LOAD <sup>(2)</sup>              | Normal mode. Fault pin low and fault register set. Fault register reset by microcontroller.                                                                                                                                                                                                                                                                                                                                      |

1. No internal current limiter. Response time of current limiter would be longer than shut-off time.
2. CHECK during PHASE 1. If max duration time of phase1 is reached (register H value) Open-load detection signal is read by control logic and validated.

Figure 6. Thermal protection

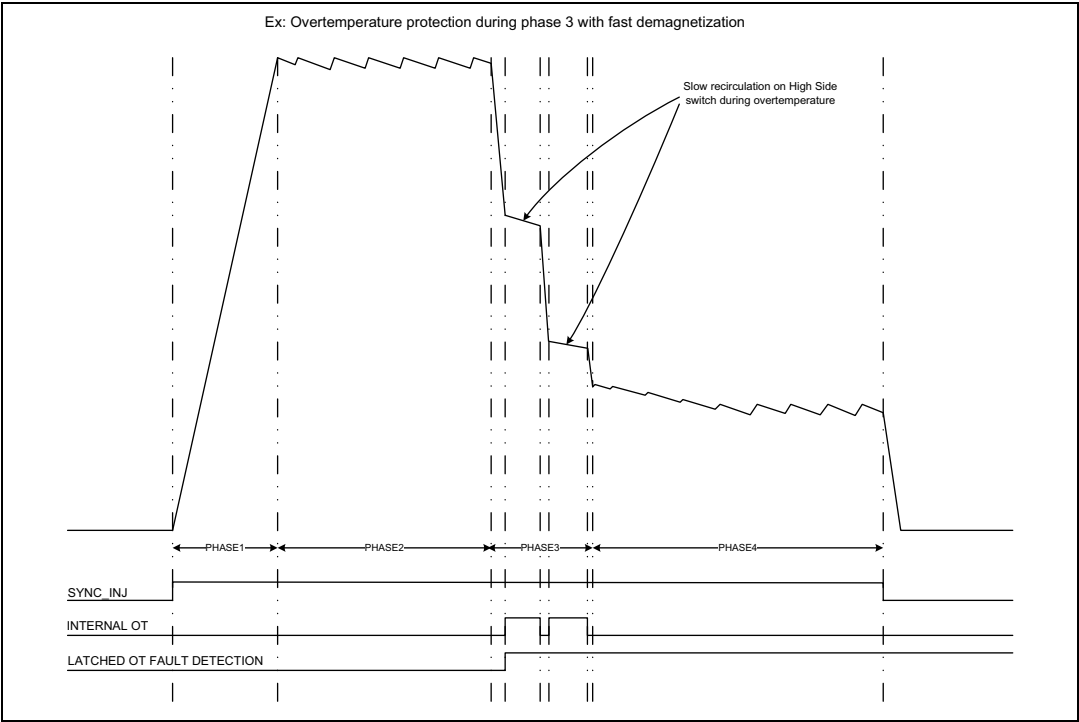


Figure 7. Short to battery protection

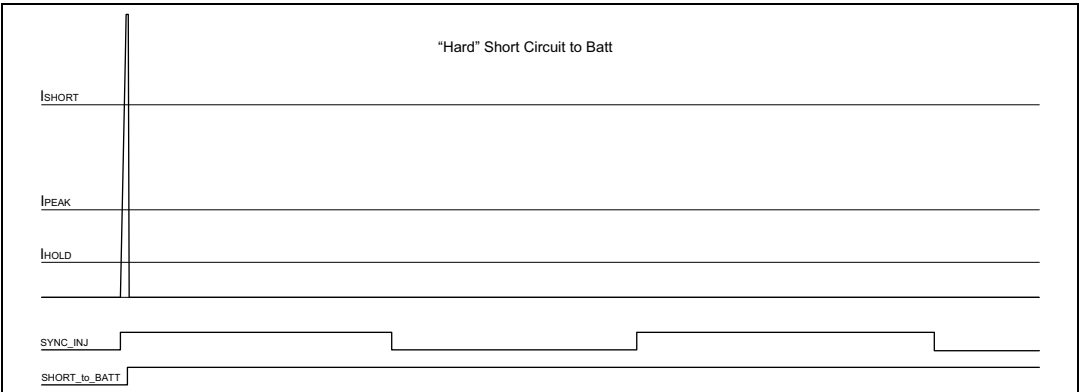


Figure 8. Soft short to battery protection

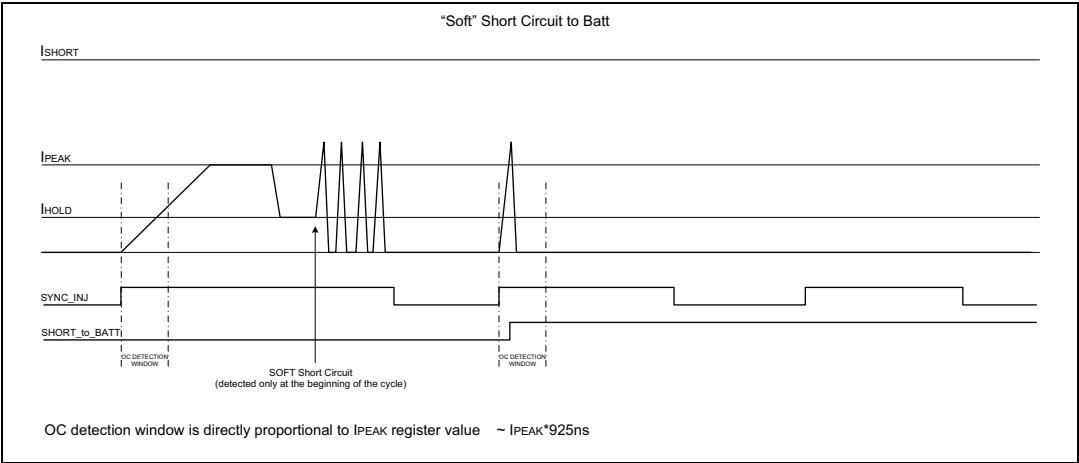
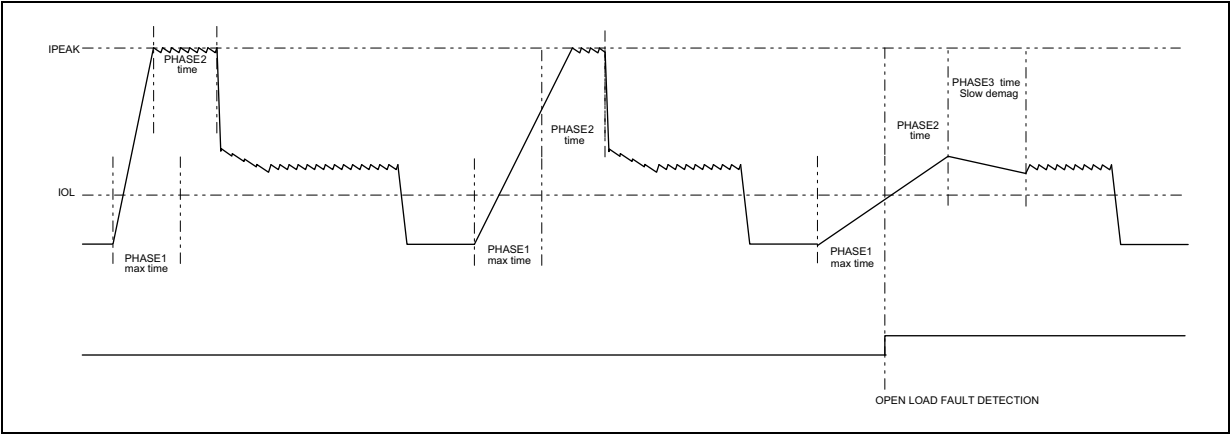


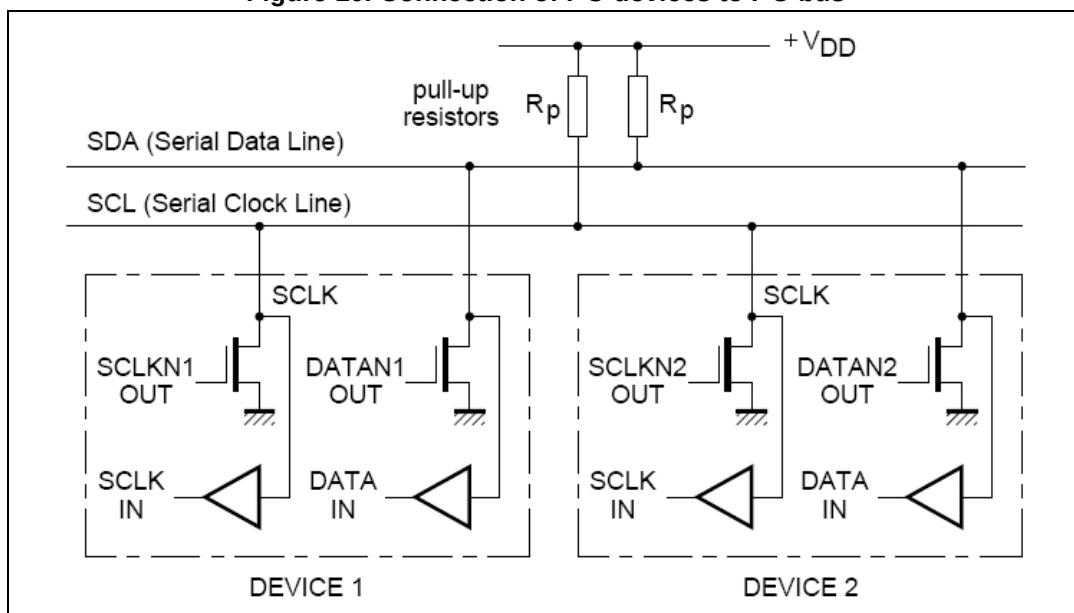
Figure 9. Open-load diagnostic



## 4 I<sup>2</sup>C protocol description

The L99SD01-E is compatible with the standard I<sup>2</sup>C serial bus. This is a two wire serial interface that uses a bi-directional data bus (SDA) and serial clock (SCL). Each device connected to the bus is recognized by a unique address (whether it is a microcontroller, memory or injector driver) and can operate as either a transmitter or receiver, depending on the function of the device. In addition to transmitters and receivers, devices can also be considered as masters or slaves when performing data transfers. A master is the device which initiates a data transfer on the bus and generates the clock signals to permit that transfer. At that time, any device addressed is considered a slave. L99SD01-E can only be a slave, transmitter or receiver, during communication.

**Figure 10. Connection of I<sup>2</sup>C-devices to I<sup>2</sup>C-bus**



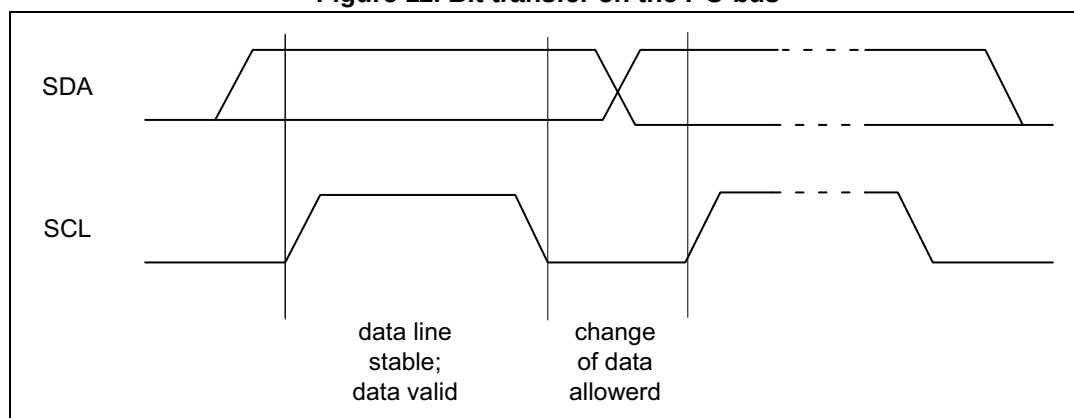
### 4.1 SDA and SCL signals

Both SDA and SCL are bidirectional lines, connected to a positive supply voltage via a current-source or pull-up resistor. When the bus is free, both lines are HIGH. The output stages of devices connected to the bus must have an open-drain or open-collector to perform the wired-AND function.

Data on the I<sup>2</sup>C bus can be transferred at rates up to 100 kbit/s in the standard-mode. The number of devices connected to the bus is limited by the max bus capacitance.

### 4.2 Data validity

The data on the SDA line must be stable during the HIGH period of the clock. The HIGH or LOW state of the data line can only change when the clock signal on the SCL line is LOW. One clock pulse is generated for each data bit transferred.

Figure 11. Bit transfer on the I<sup>2</sup>C-bus

### 4.3 START and STOP conditions

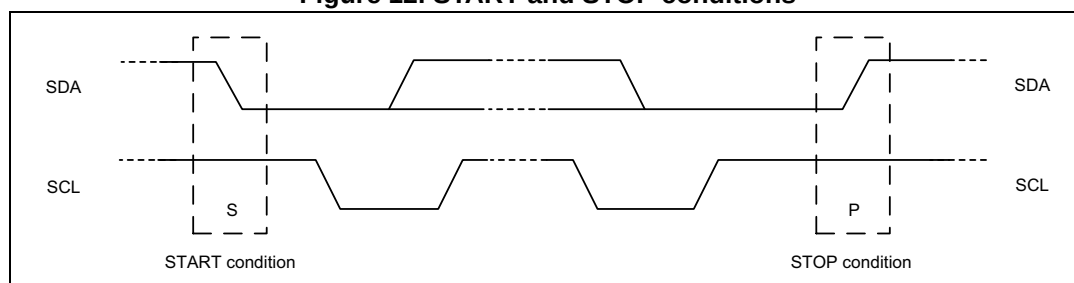
All transactions begin with a START (S) and can be terminated by a STOP (P).

A HIGH to LOW transition on the SDA line while SCL is HIGH defines a START condition. A LOW to HIGH transition on the SDA line while SCL is HIGH defines a STOP condition.

START and STOP conditions are always generated by the master. The bus is considered to be busy after the START condition. The bus is considered to be free again a certain time after a STOP condition.

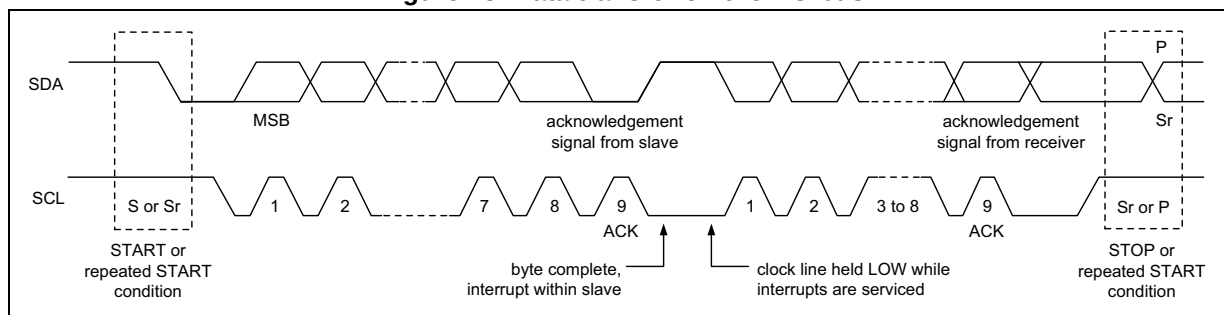
The bus stays busy if a repeated START (Sr) is generated instead of a STOP signal. In this respect, the START (S) and repeated START (Sr) conditions are functionally identical.

Figure 12. START and STOP conditions



### 4.4 Byte format

Every byte put on the SDA line must be 8 bits long. The number of bytes that can be transmitted per transfer is unrestricted. Each byte has to be followed by an Acknowledge bit. Data is transferred with the Most Significant Bit (MSB) first.

Figure 13. Data transfer on the I<sup>2</sup>C-bus

## 4.5 Acknowledge (ACK) and Not Acknowledge (NACK)

The acknowledge takes place after every byte. The acknowledge bit allows the receiver to signal the transmitter that the byte was successfully received and another byte may be sent. All clock pulses including the acknowledge 9<sup>th</sup> clock pulse are generated by the master.

The acknowledge signal is defined as follows: the transmitter releases the SDA line during the acknowledge clock pulse so the receiver can pull the SDA line LOW and it remains stable LOW during the HIGH period of this clock pulse. Setup and hold times must also be taken into account.

When the SDA remains HIGH during this 9<sup>th</sup> clock pulse, this is defined as the Not Acknowledge signal. The master can then generate either a STOP condition to abort the transfer, or a repeated START condition to start a new transfer.

## 4.6 Device addressing

Data transfers follow the format shown in fig.10. After the START condition (S), a slave address is sent. This address is 7 bits long followed by an eighth bit which is a data direction bit (R/W). A 'zero' indicates a transmission (WRITE), a 'one' indicates a request for data (READ). A data transfer is always terminated by a STOP condition (P) generated by the master. However, if a master still wishes to communicate on the bus, it can generate a repeated START condition (Sr) and address another slave without first generating a STOP condition. Various combinations of read/write formats are then possible within such a transfer.

Figure 14. Complete data transfer

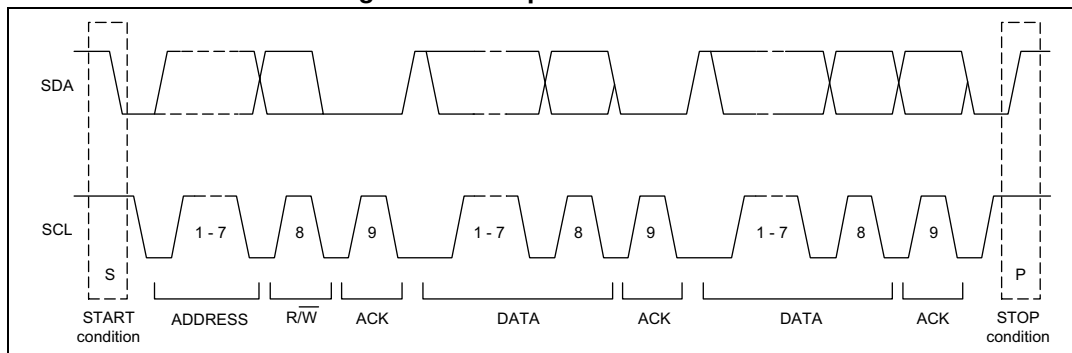
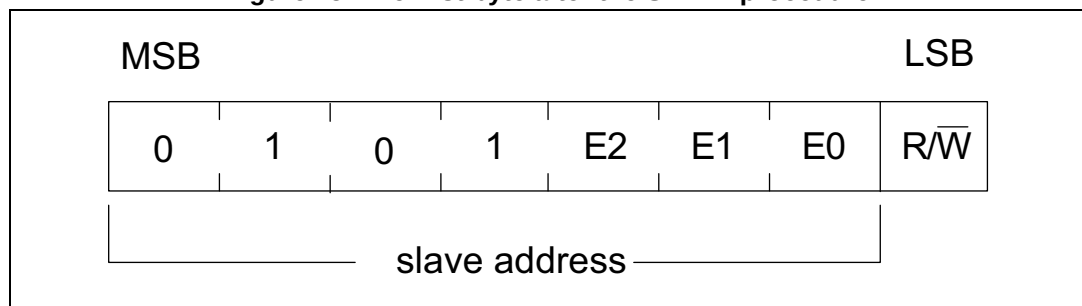


Figure 15. The first byte after the START procedure



## 4.7 Write operation

WRITE command in L99SD01-E is used to store data into volatile memory.

Master initiates a START condition (S) and then sends the first byte which is the slave address followed by the R/W= '0'. If L99SD01-E recognizes its address then it generates an ACK signal.

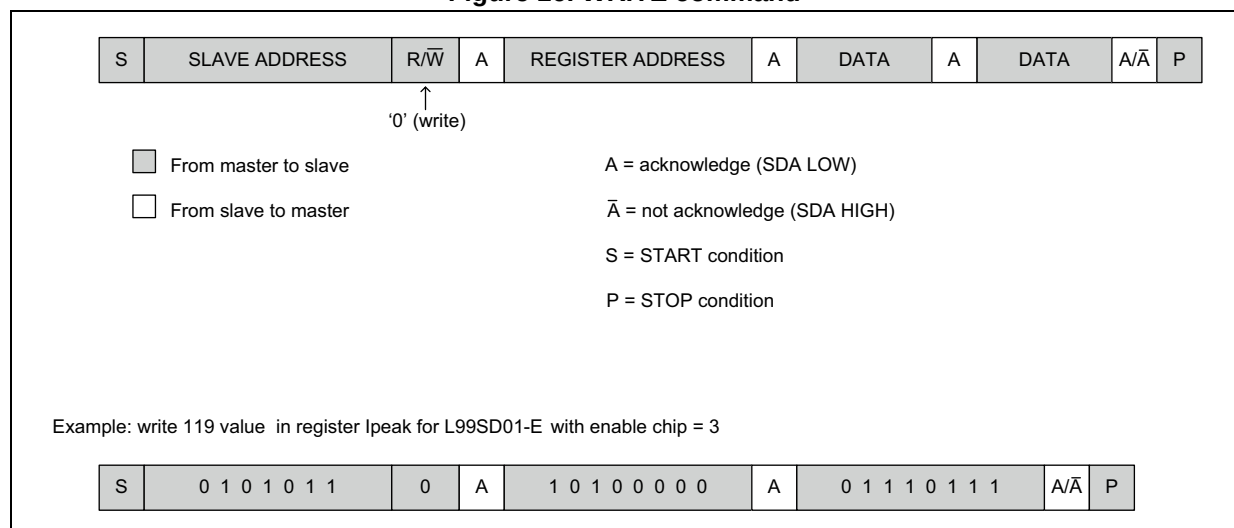
Each L99SD01-E has a different slave address. The first four bits of the address are the device type identifier and do not change for all L99SD01-E devices. The following three bits are used to address till 8 different L99SD01-E on the same bus.

Second byte sent by master in write mode is the register address where data must be written. After Acknowledge from slave, master starts to send the data, which can be one or more bytes. Eight different registers may be written in L99SD01-E. If more than eight data bytes are sent by the master, roll-over occurs.

The transfer finishes when master sends a STOP condition (P).

After the successful completion of write operations, the device internal address counter is incremented automatically, to point to the next byte address after the last one that was modified.

Figure 16. WRITE command



## 4.8 Read operation

READ command in L99SD01-E is used to read data contained into volatile memory. There are essentially two different Read operation modes: Current Read and Random Read.

In Random READ mode a dummy write is first performed to load the address into the address counter, then without sending a STOP condition, the Master sends another START condition, and repeats the slave address, with the R/W bit set to '1' (READ). At this point slave acknowledges and starts sending data output from the addressed register. One or more bytes can be sent to master. L99SD01-E stops sending data when it receives a NACK signal from master. At this point master can decide to stop transmission by sending a STOP condition or to generate a repeated START condition to start communication with another slave. At the end of communication internal address counter is incremented automatically, to point to the next byte address after the last one that was read.

In Current READ mode, following a START condition, the master sends a slave address with a R/W bit set to '1'. At this point slave acknowledges and starts sending data output from the register addressed by the internal counter. One or more bytes can be sent to master. L99SD01-E stops sending data when it receives a NACK signal from master. At this point master can decide to stop transmission by sending a STOP condition or to generate a repeated START condition to start communication with another slave.

**Figure 17. Current READ command**

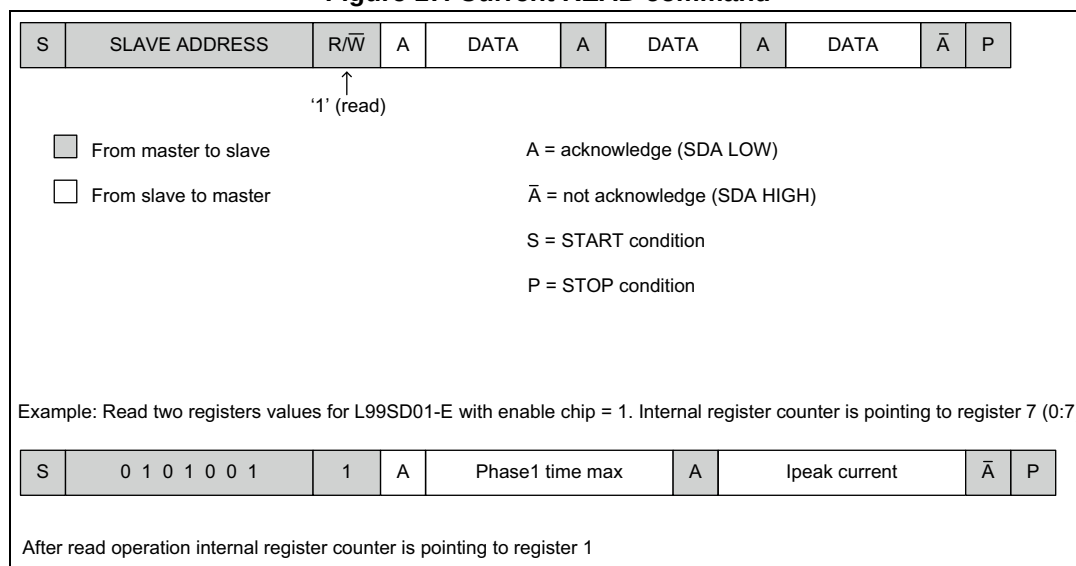
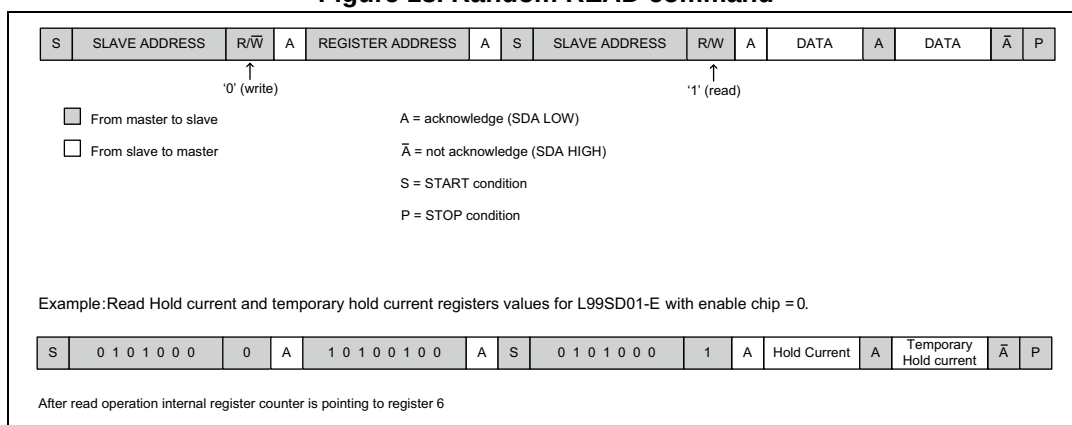


Figure 18. Random READ command



Besides the eight parameter registers, there is another eight bit register which corresponds to the fault register. It can only be reset and read via dedicated commands.

## 4.9 Registers Addresses and Fault register

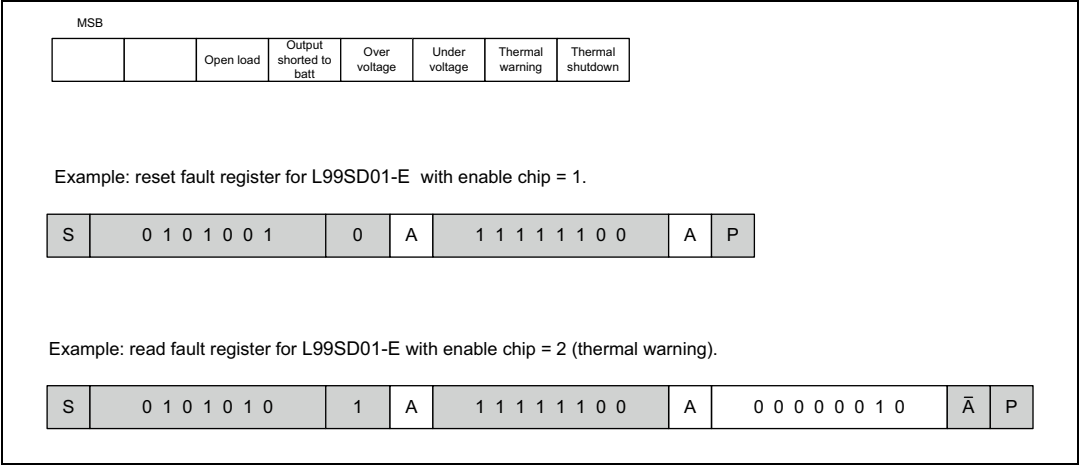
L99SD01-E does not need to be first configured via I<sup>2</sup>C-bus line. Default application parameters are hard-wired in the device. At first turn-on default application parameters are transferred inside registers which can be further modified by customer via I<sup>2</sup>C-bus if needed. In order to permit “real-time” parameter changes each register will have an equivalent temporary register to store the data until the first low-to-high transition on SYNC\_INJ signal at the end of communication. At this time temporary registers are transferred into the actual parameter registers.

Each register can be read/written via serial interface. Fault register can be read and reset (fault cleared).

Table 4. Registers addresses

|    | Register address | Register content                     | Length | Access | Purpose                   |
|----|------------------|--------------------------------------|--------|--------|---------------------------|
| R0 | 1010 0000        | I peak current                       | 1 byte | R/W    | Read/Store data           |
| R1 | 1010 0001        | Phase 2 duration                     | 1 byte | R/W    | Read/Store data           |
| R2 | 1010 0010        | Phase 3 duration                     | 1 byte | R/W    | Read/Store data           |
| R3 | 1010 0011        | Demag mod                            | 1 byte | R/W    | Read/Store data           |
| R4 | 1010 0100        | Hold Current                         | 1 byte | R/W    | Read/Store data           |
| R5 | 1010 0101        | Temporary hold current               | 1 byte | R/W    | Read/Store data           |
| R6 | 1010 0110        | Temporary hold current time duration | 1 byte | R/W    | Read/Store data           |
| R7 | 1010 0111        | Phase 1 time max                     | 1 byte | R/W    | Read/Store data           |
| R8 | 1111 1100        | Fault Register                       | 1 byte | W<br>R | Clear Fault<br>Read Fault |

Figure 19. Fault Register



## 5 Register description

### 5.1 Register A

| MSB    |        |        |        | LSB    |        |        |        |
|--------|--------|--------|--------|--------|--------|--------|--------|
| 7      | 6      | 5      | 4      | 3      | 2      | 1      | 0      |
| IPK[7] | IPK[6] | IPK[5] | IPK[4] | IPK[3] | IPK[2] | IPK[1] | IPK[0] |

**Address:** 0xA0

**Type:** R/W

**Reset:** 0010 1000b

**Description:** IPK[7...0]:  $I_{PEAK}$  current value.

$I_{PEAK}$  current in ampere can be computed as  $IPK[7...0] * 20.55 / 255$ . Value are only guaranteed between 2 A and 14 A.

### 5.2 Register B

| MSB    |        |        |        | LSB    |        |        |        |
|--------|--------|--------|--------|--------|--------|--------|--------|
| 7      | 6      | 5      | 4      | 3      | 2      | 1      | 0      |
| TPK[7] | TPK[6] | TPK[5] | TPK[4] | TPK[3] | TPK[2] | TPK[1] | TPK[0] |

**Address:** 0xA1

**Type:** R/W

**Reset:** 0101 0010b

**Description:** TPK[7...0]: Phase 2 ( $I_{PEAK}$  current) duration.

Phase 2 duration in ms can be computed as  $TPK[7...0] * 5 / 255$ .

### 5.3 Register C

| MSB    |        |        |        | LSB    |        |        |        |
|--------|--------|--------|--------|--------|--------|--------|--------|
| 7      | 6      | 5      | 4      | 3      | 2      | 1      | 0      |
| TPH[7] | TPH[6] | TPH[5] | TPH[4] | TPH[3] | TPH[2] | TPH[1] | TPH[0] |

**Address:** 0xA2

**Type:** R/W

**Reset:** 0010 0100b

**Description:** TPH[7...0]:  $t_{PEAK\_TO\_HOLD}$  (Phase 3) duration.

If DEMAG\_MODE bit is 0,  $t_{PEAK\_TO\_HOLD}$  in microseconds can be computed as  $TPH[7...0] * 500 / 255$ .

If DEMAG\_MODE bit is set to 1,  $t_{PEAK\_TO\_HOLD}$  in milliseconds can be computed as  $TPH[7...0] * 10 / 255$ .

## 5.4 Register D

| MSB      |          |          |          | LSB      |          |          |            |
|----------|----------|----------|----------|----------|----------|----------|------------|
| 7        | 6        | 5        | 4        | 3        | 2        | 1        | 0          |
| Reserved | Reserved | Reserved | Reserved | Reserved | Reserved | Reserved | DEMAG_MODE |

**Address:** 0xA3

**Type:** R/W

**Reset:** 0000 0001b

**Description:** DEMAG\_MODE: demagnetization during phase 3 is fast if this bit is set to 1 or slow otherwise.

*Note: If at the end of phase 2 the current has not reached  $I_{PEAK}$  value, slow demagnetization mode will be applied during phase 3 whatever the value of DEMAG\_MODE bit.*

## 5.5 Register E

| MSB   |       |       |       | LSB   |       |       |       |
|-------|-------|-------|-------|-------|-------|-------|-------|
| 7     | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
| IH[7] | IH[6] | IH[5] | IH[4] | IH[3] | IH[2] | IH[1] | IH[0] |

**Address:** 0xA4

**Type:** R/W

**Reset:** 0110 1001b

**Description:** IH[7...0]:  $I_{HOLD}$  current value.

$I_{HOLD}$  current value in ampere can be computed as  $IH[7...0] * 4.11 / 255$ . Value are only guaranteed between 0.5 A and 3 A.

## 5.6 Register F

| MSB      |          |          |          | LSB      |          |          |          |
|----------|----------|----------|----------|----------|----------|----------|----------|
| 7        | 6        | 5        | 4        | 3        | 2        | 1        | 0        |
| IHTMP[7] | IHTMP[6] | IHTMP[5] | IHTMP[4] | IHTMP[3] | IHTMP[2] | IHTMP[1] | IHTMP[0] |

**Address:** 0xA5

**Type:** R/W

**Reset:** 0111 1100b

**Description:** IHTMP[7...0]:  $I_{HOLD\_TEMP}$  current value (reference current during Phase 4).

The current value in ampere can be computed as  $IHTMP[7...0] * 4.11 / 255$ . Value are only guaranteed between 0.5 A and 3.5 A.

## 5.7 Register G

| MSB      |          |          |          | LSB      |          |          |          |
|----------|----------|----------|----------|----------|----------|----------|----------|
| 7        | 6        | 5        | 4        | 3        | 2        | 1        | 0        |
| THTMP[7] | THTMP[6] | THTMP[5] | THTMP[4] | THTMP[3] | THTMP[2] | THTMP[1] | THTMP[0] |

**Address:** 0xA6

**Type:** R/W

**Reset:** 0000 0000b

**Description:** THTMP[7..0]:  $I_{HOLD\_TEMP}$  duration inside Phase 4.

Phase3 duration in ms can be computed as  $THTMP[7...0] * 5 / 255$ .

## 5.8 Register H

| MSB      |          |          |          | LSB      |          |          |          |
|----------|----------|----------|----------|----------|----------|----------|----------|
| 7        | 6        | 5        | 4        | 3        | 2        | 1        | 0        |
| TNPKM[7] | TNPKM[6] | TNPKM[5] | TNPKM[4] | TNPKM[3] | TNPKM[2] | TNPKM[1] | TNPKM[0] |

**Address:** 0xA7

**Type:** R/W

**Reset:** 0100 0000b

**Description:** TNPKM[7...0]:  $t_{NO\_PEAK\_MAX}$  value.

During phase 1, if  $I_{PEAK}$  value is not reached within  $t_{NO\_PEAK\_MAX}$ , the device switches into Phase 2.  $t_{NO\_PEAK\_MAX}$  in millisecond can be computed as  $TNPKM[7...0] * 10 / 255$ .

## 5.9 Fault register

| MSB      |          |           |                      | LSB          |               |                 |                  |
|----------|----------|-----------|----------------------|--------------|---------------|-----------------|------------------|
| 7        | 6        | 5         | 4                    | 3            | 2             | 1               | 0                |
| Reserved | Reserved | Open Load | OUT short to battery | Over voltage | Under voltage | Thermal warning | Thermal shutdown |

**Address:** 0xFC

**Type:** R/W. Any write action will result in a register clear.

**Reset:** 0000 0000b

Bit [4] Output shorted to battery flag.

Bit is set by HW when an over current is detected on the output at the beginning of the injection cycle (phases 1 and 2). Write the register to clear this bit.

Bit [3] Over voltage flag.

Bit is set by HW when an over voltage is detected on the battery voltage, write the register to clear this bit.

Bit [2] Under voltage flag.

Bit is set by HW when an under voltage is detected on the battery voltage, write the register to clear this bit.

Bit [1] Thermal warning flag.

Bit is set by HW when the die temperature exceeds  $T_{TW}$  threshold, write the register to clear this bit.

Bit [0] Thermal shutdown flag.

Bit is set by HW when the die temperature exceeds  $T_{TSD}$  threshold, a register writing clears this bit only if the die temperature is lower than  $T_{TR}$ .

## 6 Electrical specification

### 6.1 Absolute maximum rating

Table 5. Absolute maximum rating

| Symbol                                                                                                                                                                        | Parameter                                                                                                                                               | Value                             | Unit               |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------|--------------------|
| $V_{BATT}$                                                                                                                                                                    | Maximum DC supply voltage                                                                                                                               | 40                                | V                  |
| $V_{BATT\_REV}$                                                                                                                                                               | Reverse DC supply voltage                                                                                                                               | -0.3                              | V                  |
| $V_{LOAD}$                                                                                                                                                                    | Maximum DC load voltage                                                                                                                                 | Internally limited                | V                  |
| $I_{LOAD}$                                                                                                                                                                    | Maximum DC load current                                                                                                                                 | Internally limited to $I_{SHORT}$ | A                  |
| $I_{R(Load)}$                                                                                                                                                                 | Maximum reverse output current, $T_C = 25^{\circ}\text{C}$ ; $t = 5\text{ ms}$ .                                                                        | -20                               | A                  |
| $E_{AS}$                                                                                                                                                                      | Single pulse energy S1 switch; $V_{BATT} = 13.5\text{ V}$ ; $T_j = 150^{\circ}\text{C}$ ; $L = 6\text{ mH}$ ; $R_L = 0\ \Omega$ , typical clamp voltage | 88                                | mJ                 |
| $E_{REP1}$                                                                                                                                                                    | Repetitive energy S1 switch. $V_{BATT} = 13.5\text{ V}$ ; $T_j = 125^{\circ}\text{C}$ ; $L = 6\text{ mH}$ ; $R_L = 0\ \Omega$ , typical clamp voltage   | 38.6                              | mJ                 |
| $E_{REP2}$                                                                                                                                                                    | Repetitive energy S1 switch. $V_{BATT} = 13.5\text{ V}$ ; $T_j = -40^{\circ}\text{C}$ ; $L = 6\text{ mH}$ ; $R_L = 0\ \Omega$ , typical clamp voltage   | 70                                | mJ                 |
| $V_{C3V3}$                                                                                                                                                                    | 3.3 V logic supply voltage range                                                                                                                        | -0.3 to 3.6                       | V                  |
| $V_{DDL}$                                                                                                                                                                     | 5 V external supply voltage                                                                                                                             | 5.5                               | V                  |
| $V_{SYNC\_INJ}$<br>$V_{E0}\ V_{E1}\ V_{E2}$<br>$V_{CHECK\_SIGNAL}$<br>$V_{SCL}$<br>$V_{SDA}\ V_{MAINT\_IPK}$<br>$V_{PWM}$<br>$V_{CLAMP\_FLAG}$<br>$V_{FAULT}$<br>$V_{ENABLE}$ | Logic input / output voltage range                                                                                                                      | -0.3 to $V_{DDL}+0.3$             | V                  |
| $V_{IN\_SIGNAL}$<br>$V_{REC}$                                                                                                                                                 | HV signal pins                                                                                                                                          | -0.3 to $V_{BATT}$                | V                  |
| $V_{OUT}$                                                                                                                                                                     | Output pin                                                                                                                                              | 55                                | V                  |
| $V_{CTANK}$                                                                                                                                                                   | Maximum charge pump output voltage                                                                                                                      | $V_{BATT} + 15\text{V}$           | V                  |
| $V_{CPUMP1}$<br>$V_{CPUMP2}$                                                                                                                                                  | Maximum charge pump pins voltage                                                                                                                        | $V_{BATT}$                        | V                  |
| $V_{ESD}$                                                                                                                                                                     | Electrostatic discharge ( $R = 1.5\text{k}\Omega$ , $C = 100\text{pF}$ , all pins)                                                                      | +/-2000                           | V                  |
| $T_j$                                                                                                                                                                         | Junction operating temperature                                                                                                                          | -40 to 150                        | $^{\circ}\text{C}$ |
| $T_{STG}$                                                                                                                                                                     | Storage temperature                                                                                                                                     | -55 to 150                        | $^{\circ}\text{C}$ |

## 6.2 Thermal data

Table 6. Thermal data

| Symbol        | Parameter                           | Value                         | Unit |
|---------------|-------------------------------------|-------------------------------|------|
| $R_{thj-amb}$ | Thermal resistance junction-ambient | See <a href="#">Figure 23</a> | °C/W |

## 6.3 Electrical characteristics

6 V <  $V_{BATT}$  < 28 V; -40°C <  $T_j$  < 150°C; unless otherwise specified

Table 7.  $V_{BATT}$  supply

| Symbol         | Parameter                                     | Test conditions                                                                                                            | Min | Typ | Max | Unit |
|----------------|-----------------------------------------------|----------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|------|
| $V_{BATT}$     | Operating supply voltage                      |                                                                                                                            | 6   |     | 28  | V    |
| $I_{SON}$      | $V_{BATT}$ DC supply current                  | $V_{BATT} = 13\text{ V}$ ; $V_{DDL} = 5\text{ V}$ ;<br>$V_{ENABLE} = 5\text{ V}$ ; Output floating                         |     | 2   |     | mA   |
| $I_{STBY}$     | $V_{BATT} + V_{DDL}$ quiescent supply current | $V_{BATT} = 13\text{ V}$ ; $V_{DDL} = 5\text{ V}$ ;<br>$V_{ENABLE} = 0\text{ V}$ ; Output floating<br>-40°C < $T_j$ < 85°C |     |     | 10  | μA   |
| $I_{DDL}$      | $V_{DDL}$ DC supply current                   | $V_{BATT} = 13\text{ V}$ ; $V_{DDL} = 5\text{ V}$ ;<br>$V_{ENABLE} = 5\text{ V}$                                           |     | 8   | 10  | mA   |
| $V_{OV}$       | Overvoltage threshold                         |                                                                                                                            | 34  |     | 40  | V    |
| $V_{UV}$       | Undervoltage threshold                        |                                                                                                                            |     |     | 6   | V    |
| $V_{UV\_hyst}$ | Undervoltage threshold hysteresis             |                                                                                                                            | 0.4 | 0.6 |     | V    |

Table 8. Power switches  $S_1 - S_2$ 

| Symbol | Parameter                              | Test conditions                                                                                      | Min | Typ | Max   | Unit |
|--------|----------------------------------------|------------------------------------------------------------------------------------------------------|-----|-----|-------|------|
| RON1   | On state resistance (excitation path)  | $I_{LOAD} = 5\text{ A}$ ; $S_1 = \text{ON}$ ;<br>$V_{BATT} = 13\text{ V}$ ; $T_j = 25^\circ\text{C}$ | —   | —   | 0.060 | Ω    |
|        |                                        | $I_{LOAD} = 5\text{ A}$ ; $S_1 = \text{ON}$ ;<br>$V_{BATT} = 13\text{ V}$                            | —   | —   | 0.120 | Ω    |
|        |                                        | $I_{LOAD} = 5\text{ A}$ ; $S_1 = \text{ON}$ ;<br>$V_{BATT} = 6\text{ V}$                             | —   | —   | 0.150 | Ω    |
| RON2   | On state resistance Recirculation Path | $I_{LOAD} = 5\text{ A}$ ; $S_2 = \text{ON}$ ;<br>$V_{BATT} = 13\text{ V}$ ; $T_j = 25^\circ\text{C}$ | —   | —   | 0.060 | Ω    |
|        |                                        | $I_{LOAD} = 5\text{ A}$ ; $S_2 = \text{ON}$ ;<br>$V_{BATT} = 13\text{ V}$                            | —   | —   | 0.120 | Ω    |
|        |                                        | $I_{LOAD} = 5\text{ A}$ ; $S_2 = \text{ON}$ ;<br>$V_{BATT} = 6\text{ V}$                             | —   | —   | 0.150 | Ω    |

Table 9. S<sub>1</sub> switching (excitation path)

| Symbol                | Parameter                           | Test conditions                                                             | Min | Typ  | Max  | Unit |
|-----------------------|-------------------------------------|-----------------------------------------------------------------------------|-----|------|------|------|
| TD <sub>ON_S1</sub>   | Turn-on delay time                  | V <sub>BATT</sub> = 13.5 V;<br>R <sub>LOAD</sub> = 2.5 Ω                    | 100 | 180  | 300  | ns   |
| T <sub>R_S1</sub>     | Rise time of output voltage         |                                                                             |     | 500  | 900  | ns   |
| TD <sub>OFF_S1</sub>  | Turn-off delay time                 |                                                                             | 600 | 1400 | 2000 | ns   |
| T <sub>F_S1</sub>     | Fall time of output voltage         |                                                                             |     | 600  | 1000 | ns   |
| V <sub>CLAMP_S1</sub> | Switch S <sub>1</sub> clamp voltage | I <sub>LOAD</sub> = 0.5/14 A; S <sub>1</sub> = off;<br>S <sub>2</sub> = off | 44  |      | 55   | V    |

Table 10. Switching (recirculating path)

| Symbol               | Parameter                   | Test conditions                                          | Min | Typ  | Max  | Unit |
|----------------------|-----------------------------|----------------------------------------------------------|-----|------|------|------|
| TD <sub>ON_S2</sub>  | Turn-on delay time          | V <sub>BATT</sub> = 13.5 V;<br>R <sub>LOAD</sub> = 2.5 Ω | —   | 280  | 600  | ns   |
| T <sub>R_S2</sub>    | Rise time of output voltage |                                                          | —   | 1500 | 3000 | ns   |
| TD <sub>OFF_S2</sub> | Turn-off delay time         |                                                          | —   | 150  | 600  | ns   |
| T <sub>F_S2</sub>    | Fall time of output voltage |                                                          | —   | 200  | 800  | ns   |

Table 11. V<sub>DDL</sub> undervoltage detection

| Symbol                | Parameter                 | Test conditions                            | Min | Typ | Max | Unit |
|-----------------------|---------------------------|--------------------------------------------|-----|-----|-----|------|
| V <sub>POR_OFF</sub>  | power-on-reset threshold  | V <sub>DDL</sub> increasing                | 3.8 | 4   | 4.2 | V    |
| V <sub>POR_ON</sub>   | power-on-reset threshold  | V <sub>DDL</sub> decreasing                | 3.2 | 3.4 | 3.6 | V    |
| V <sub>POR_hyst</sub> | power-on-reset hysteresis | V <sub>POR_OFF</sub> - V <sub>POR_ON</sub> | 0.3 |     |     | V    |

Table 12. Enable

| Symbol                   | Parameter                 | Test conditions           | Min | Typ | Max | Unit |
|--------------------------|---------------------------|---------------------------|-----|-----|-----|------|
| V <sub>ENABLE_H</sub>    | Enable voltage threshold  | V <sub>BATT</sub> = 13 V  | 1   | 1.8 | 2.3 | V    |
| V <sub>ENABLE_L</sub>    | Enable voltage reset      | V <sub>BATT</sub> = 13 V  | 0.8 | 1.5 | 1.9 | V    |
| V <sub>ENABLE_HYST</sub> | Enable voltage hysteresis | V <sub>BATT</sub> = 13 V  | 0.1 | 0.3 |     | V    |
| I <sub>ENABLE</sub>      | Enable pull down current  | V <sub>ENABLE</sub> = 5 V | 20  | 50  | 100 | μA   |

Table 13. Input: SYNC\_INJ

| Symbol                 | Parameter                           | Test conditions               | Min  | Typ | Max  | Unit |
|------------------------|-------------------------------------|-------------------------------|------|-----|------|------|
| V <sub>SYNC_L</sub>    | Input low level voltage             | V <sub>DDL</sub> = 5 V        |      |     | 1.08 | V    |
| V <sub>SYNC_H</sub>    | Input high level voltage            | V <sub>DDL</sub> = 5 V        | 2.1  |     |      | V    |
| V <sub>SYNC_HYST</sub> | Input hysteresis voltage            | V <sub>DDL</sub> = 5 V        | 0.15 |     |      | V    |
| I <sub>SYNC_INJ</sub>  | pull down current at SYNC_INJ input | V <sub>SYNC_INJ</sub> = 1.5 V | 20   | 50  | 80   | μA   |

Table 14. Input: PWM

| Symbol                | Parameter                      | Test conditions          | Min  | Typ | Max  | Unit |
|-----------------------|--------------------------------|--------------------------|------|-----|------|------|
| V <sub>PWM_L</sub>    | Input low level voltage        | V <sub>DDL</sub> = 5 V   |      |     | 1.08 | V    |
| V <sub>PWM_H</sub>    | Input high level voltage       | V <sub>DDL</sub> = 5 V   | 2.1  |     |      | V    |
| V <sub>PWM_HYST</sub> | Input hysteresis voltage       | V <sub>DDL</sub> = 5 V   | 0.15 |     |      | V    |
| I <sub>PWM</sub>      | Pull down current at PWM input | V <sub>PWM</sub> = 1.5 V | 20   | 50  | 80   | μA   |

Table 15. Inputs: E0, E1, E2

| Symbol               | Parameter                     | Test conditions        | Min  | Typ | Max  | Unit |
|----------------------|-------------------------------|------------------------|------|-----|------|------|
| V <sub>Ex_L</sub>    | Input low level voltage       | V <sub>DDL</sub> = 5V  |      |     | 1.08 | V    |
| V <sub>Ex_H</sub>    | Input high level voltage      | V <sub>DDL</sub> = 5V  | 2.1  |     |      | V    |
| V <sub>Ex_HYST</sub> | Input hysteresis voltage      | V <sub>DDL</sub> = 5V  | 0.15 |     |      | V    |
| I <sub>Ex_IN</sub>   | Pull down current at Ex input | V <sub>Ex</sub> = 1.5V | 20   | 50  | 80   | μA   |

Table 16. IN\_SIGNAL VOLTAGE MONITOR, CHECK\_SIGNAL

| Symbol                      | Parameter                          | Test conditions                                                   | Min                      | Typ                       | Max                      | Unit |
|-----------------------------|------------------------------------|-------------------------------------------------------------------|--------------------------|---------------------------|--------------------------|------|
| V <sub>IN_SIGNAL_L</sub>    | Input low level voltage threshold  |                                                                   | 0.4<br>V <sub>BATT</sub> | 0.45<br>V <sub>BATT</sub> | 0.5<br>V <sub>BATT</sub> | V    |
| V <sub>IN_SIGNAL_H</sub>    | Input high level voltage threshold |                                                                   | 0.5<br>V <sub>BATT</sub> | 0.55<br>V <sub>BATT</sub> | 0.6<br>V <sub>BATT</sub> | V    |
| V <sub>IN_SIGNAL_HYST</sub> | Input hysteresis voltage           |                                                                   |                          | 0.1<br>V <sub>BATT</sub>  |                          | V    |
| V <sub>CHECK_SIGNAL</sub>   | Check_signal output voltage        | V <sub>IN_SIGNAL</sub> = 0 V;<br>I <sub>CHECK_SIGNAL</sub> = 1 mA |                          |                           | 0.9                      | V    |

Table 17. Differential current sense amplifier

| Symbol               | Parameter                         | Test conditions | Min | Typ | Max | Unit |
|----------------------|-----------------------------------|-----------------|-----|-----|-----|------|
| V <sub>ICM_AMP</sub> | Input voltage range – common mode |                 | 0   |     | 0.8 | V    |

Table 17. Differential current sense amplifier (continued)

| Symbol                | Parameter                               | Test conditions                                                                                                                   | Min  | Typ | Max | Unit          |
|-----------------------|-----------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------|------|-----|-----|---------------|
| $V_{IDIFF\_AMP}$      | Input voltage range – differential mode | Gain = 20; $V_{DDL} = 5\text{ V}$                                                                                                 | 10   |     | 80  | mV            |
|                       |                                         | Gain = 4; $V_{DDL} = 5\text{ V}$                                                                                                  | 20   |     | 400 | mV            |
| $V_{IOFF\_AMP}$       | Input offset voltage                    | $V_{DDL} = 5\text{ V}$                                                                                                            | -500 |     | 500 | $\mu\text{V}$ |
| $\text{Gain}_{AMP}$   | Opamp gain                              | $I_{LOAD} = I_{HOLD}$                                                                                                             |      | 20  |     |               |
|                       |                                         | $I_{LOAD} = I_{PEAK}$                                                                                                             |      | 4   |     |               |
| $\text{GBW}_{AMP}$    | Gain bandwidth product                  | $G = 20$                                                                                                                          |      | 2   |     | MHz           |
|                       |                                         | $G = 4$                                                                                                                           |      | 0.4 |     | MHz           |
| $\text{CMRR}_{AMP}$   | Input common mode rejection             | $F = 1\text{ KHz}$                                                                                                                | 60   |     |     | dB            |
| $\text{PSRR}^+_{AMP}$ | 3.3 V power supply rejection ratio      |                                                                                                                                   |      | 55  |     | dB            |
| $\text{PSRR}^-_{AMP}$ | GND power supply rejection ratio        |                                                                                                                                   |      | 40  |     | dB            |
| $T_{SETTLING\_R}$     | Rising settling time                    | $G = 20$ ; $(V_{RSP} - V_{RSN}) = 0\text{ V}$ to 10 mV in 10 ns<br>$G = 4$ ; $(V_{RSP} - V_{RSN}) = 0\text{ V}$ to 20 mV in 10 ns |      |     | 3.5 | $\mu\text{s}$ |
| $T_{SETTLING\_F}$     | Falling settling time                   | $G = 20$ ; $(V_{RSP} - V_{RSN}) = 10\text{ mV}$ to 0 V in 10 ns<br>$G = 4$ ; $(V_{RSP} - V_{RSN}) = 20\text{ mV}$ to 0 V in 10 ns |      |     | 3.5 | $\mu\text{s}$ |

Table 18. Current sense comparator

| Symbol              | Parameter                         | Test conditions                           | Min  | Typ | Max | Unit |
|---------------------|-----------------------------------|-------------------------------------------|------|-----|-----|------|
| $V_{ICM\_PWMCOMP}$  | Input voltage range – common mode |                                           | 0.05 | —   | 2   | V    |
| $V_{IOFF\_PWMCOMP}$ | Input offset voltage              | $V_{DDL} = 5\text{ V}$                    | -15  | —   | 6   | mV   |
| $T_{DPWMCOMP}$      | Input to output delay             | $V_{INPUT}$ from 200 mV to 1.7 V in 10 ns |      | —   | 200 | ns   |

Table 19. 8-bit digital to analog converter

| Symbol         | Parameter                    | Test conditions | Min | Typ   | Max | Unit |
|----------------|------------------------------|-----------------|-----|-------|-----|------|
| $V_{LSB\_DAC}$ | Less significant bit voltage |                 | —   | 4.851 | —   | mV   |

Table 20. S<sub>1</sub> protections and diagnostic

| Symbol                     | Parameter                                       | Test conditions                                              | Min                             | Typ                  | Max                             | Unit |
|----------------------------|-------------------------------------------------|--------------------------------------------------------------|---------------------------------|----------------------|---------------------------------|------|
| T <sub>TW</sub>            | Thermal warning threshold junction temperature  | S <sub>1</sub> = ON                                          | 130                             |                      |                                 | °C   |
| T <sub>TSD</sub>           | Thermal shutdown threshold junction temperature | S <sub>1</sub> = ON                                          | 155                             | 175                  |                                 | °C   |
| T <sub>TR</sub>            | Thermal reset threshold junction temperature    | S <sub>1</sub> = ON                                          | 130                             |                      |                                 | °C   |
| I <sub>SHORT</sub>         | Over current detection                          | S <sub>1</sub> = ON                                          | 15                              |                      |                                 | A    |
| I <sub>OL</sub>            | Open-load detection                             | S <sub>1</sub> = ON;<br>I <sub>PEAK</sub> = 3.2 A            | 0.2 *<br>(I <sub>PEAK</sub> /4) | I <sub>PEAK</sub> /4 | 1.2 *<br>(I <sub>PEAK</sub> /4) | A    |
|                            |                                                 | S <sub>1</sub> = ON; I <sub>PEAK</sub> = 5 A                 | 0.4 *<br>(I <sub>PEAK</sub> /4) | I <sub>PEAK</sub> /4 | 1.2 *<br>(I <sub>PEAK</sub> /4) | A    |
|                            |                                                 | S <sub>1</sub> = ON; I <sub>PEAK</sub> ≥ 8 A                 | 0.7 *<br>(I <sub>PEAK</sub> /4) | I <sub>PEAK</sub> /4 | 1.3 *<br>(I <sub>PEAK</sub> /4) | A    |
| V <sub>FAULT_OUT</sub>     | Status output voltage                           | Diagnostic output active (low);<br>I <sub>FAULT</sub> = 1 mA |                                 |                      | 0.9                             | V    |
| V <sub>CLAMPFLAG_OUT</sub> | Clamp diagnostic pin output voltage             | I <sub>CLAMPFLAG</sub> = 100 μA                              |                                 |                      | 0.1                             | V    |
|                            |                                                 | I <sub>CLAMPFLAG</sub> = -100 μA                             | V <sub>DDL</sub> - 0.1          |                      |                                 | V    |
| V <sub>MAINTIPK_OUT</sub>  | MAINT_IPK diagnostic pin voltage                | I <sub>MAINTIPK</sub> = 100 μA                               |                                 |                      | 0.1                             | V    |
|                            |                                                 | I <sub>MAINTIPK</sub> = -100 μA                              | V <sub>DDL</sub> - 0.1          |                      |                                 | V    |

Table 21. Application registers range

| Symbol                    | Parameter  | Test conditions                        | Min | Typ | Max   | Unit |
|---------------------------|------------|----------------------------------------|-----|-----|-------|------|
| I <sub>PEAK</sub>         | Register A | Application useful range = 2 → 14 A    | 0   | 3.2 | 20.55 | A    |
| I <sub>HOLD</sub>         | Register E | Application useful range = 0.5 → 3 A   | 0   | 1.7 | 4.11  | A    |
| I <sub>HOLD_TEMP</sub>    | Register F | Application useful range = 0.5 → 3.5 A | 0   | 2   | 4.11  | A    |
| t <sub>PEAK</sub>         | Register B |                                        | 0   | 1.6 | 5     | ms   |
| t <sub>HOLD_TEMP</sub>    | Register G |                                        | 0   | 0   | 5     | ms   |
| t <sub>NO_PEAK_MAX</sub>  | Register H |                                        | 0   | 2.5 | 10    | ms   |
| t <sub>PEAK_TO_HOLD</sub> | Register C | DEMAG MODE = 0 (slow)                  | 0   |     | 10    | ms   |
|                           |            | DEMAG MODE = 1 (fast)                  | 0   | 70  | 500   | μs   |

Table 22. I<sub>PEAK</sub>, I<sub>HOLD</sub> (-40 °C < T<sub>j</sub> < 150 °C, unless otherwise specified)

| Symbol             | Parameter      | Test conditions <sup>(1)</sup> | Min   | Typ | Max   | Unit |
|--------------------|----------------|--------------------------------|-------|-----|-------|------|
| I <sub>PEAK</sub>  | Peak current   | RegisterA = IDEFAULT           | 2.72  | 3.2 | 3.7   | A    |
|                    |                | RegisterA = 2 A                | 1.60  | 2   | 2.40  | A    |
|                    |                | T = 125°C; RegisterA = 2 A     | 1.70  | 2   | 2.30  | A    |
|                    |                | RegisterA = 5 A                | 4.25  | 5   | 5.75  | A    |
|                    |                | RegisterA = 8 A                | 6.8   | 8   | 9.2   | A    |
|                    |                | T = 125°C; RegisterA = 14 A    | 12.6  | 14  | 15.4  | A    |
|                    |                | RegisterA = 14 A               | 11.9  | 14  | 16.1  | A    |
| I <sub>HOLD</sub>  | Hold current   | RegisterE = IDEFAULT           | 1.445 | 1.7 | 1.955 | A    |
|                    |                | T = 125°C; RegisterE = 0.5 A   | 0.325 | 0.5 | 0.6   | A    |
|                    |                | T = 125°C; RegisterE = 1 A     | 0.9   | 1   | 1.1   | A    |
|                    |                | RegisterE = 1 A                | 0.85  | 1   | 1.15  | A    |
|                    |                | RegisterE = 3 A                | 2.55  | 3   | 3.45  | A    |
| F <sub>PWM</sub>   | PWM frequency  | Design guaranteed              | 10    | 20  |       | KHz  |
| D <sub>CYCLE</sub> | PWM duty cycle | F <sub>PWM</sub> = 20 KHz      | 0.15  |     |       |      |

1. V<sub>BATT</sub> > 8 V

Table 23. Charge pump

| Symbol             | Parameter                                                             | Test conditions                                                                  | Min                   | Typ                   | Max                    | Unit |
|--------------------|-----------------------------------------------------------------------|----------------------------------------------------------------------------------|-----------------------|-----------------------|------------------------|------|
| V <sub>CP</sub>    | Charge pump output voltage <sup>(1)</sup>                             | I <sub>CP</sub> = 200 μA                                                         | V <sub>BATT</sub> + 7 | V <sub>BATT</sub> + 9 | V <sub>BATT</sub> + 13 | V    |
| C <sub>PUMP1</sub> | External charge pump capacitor                                        |                                                                                  |                       | 4.7                   |                        | nF   |
| C <sub>PUMP2</sub> | External charge pump capacitor                                        |                                                                                  |                       | 4.7                   |                        | nF   |
| C <sub>TANK</sub>  | External charge pump capacitor for S <sub>2</sub> driver peak current |                                                                                  |                       | 100                   |                        | nF   |
| I <sub>CP1</sub>   | Charge pump output current positive                                   | V <sub>BATT</sub> + 7 V < V <sub>CTAK</sub> < V <sub>BATT</sub> + 13 V test mode | 15                    | 27                    | 34                     | mA   |
| I <sub>CP2</sub>   | Charge pump output current negative                                   | V <sub>BATT</sub> + 7 V < V <sub>CTAK</sub> < V <sub>BATT</sub> + 13 V test mode | -140                  | -100                  | -55                    | mA   |

1. Guaranteed by design using suggested external network:  
 C<sub>PUMP1</sub>, C<sub>PUMP2</sub>: 4.7 nF - 50 V ceramic capacitors;  
 C<sub>TANK</sub>: 100 nF - 50 V ceramic capacitor;  
 Charge pump diodes: BAT41 type

Table 24. I<sup>2</sup>C-bus SDA, SCL I/O stages

| Symbol           | Parameter                                                         | Test conditions                                                  | Min                      | Typ | Max                     | Unit |
|------------------|-------------------------------------------------------------------|------------------------------------------------------------------|--------------------------|-----|-------------------------|------|
| V <sub>IL</sub>  | Low level input voltage                                           |                                                                  |                          | —   | 0.3 * V <sub>C3V3</sub> | V    |
| V <sub>IH</sub>  | High level input voltage                                          |                                                                  | 0.7 * V <sub>C3V3</sub>  | —   |                         | V    |
| V <sub>HYS</sub> | Hysteresis of Schmitt trigger inputs                              |                                                                  | 0.05 * V <sub>C3V3</sub> | —   |                         | V    |
| V <sub>OL</sub>  | Low level output voltage                                          | I <sub>SINK</sub> = 3 mA                                         |                          | —   | 0.4                     | V    |
| I <sub>OL</sub>  | Low level output current                                          | V <sub>OL</sub> = 0.4 V                                          | 3                        | —   |                         | mA   |
| t <sub>OFF</sub> | Output fall time from V <sub>IHmin</sub> to V <sub>ILmax</sub>    |                                                                  |                          | —   | 250                     | ns   |
| t <sub>SP</sub>  | Pulse width of spikes that must be suppressed by the input filter |                                                                  |                          | —   | 50                      | ns   |
| I <sub>i</sub>   | Input current                                                     | 0.1 * V <sub>DDL</sub> < V <sub>I</sub> < 0.9 * V <sub>DDL</sub> | -10                      | —   | 10                      | μA   |
| C <sub>i</sub>   | I/O pin capacitance                                               |                                                                  |                          | —   | 10                      | pF   |

Table 25. I<sup>2</sup>C-bus SDA, SCL bus lines characteristics

| Symbol                                                                                                                                                             | Parameter                                        | Test conditions                                      | Min                | Typ | Max            | Unit |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------|------------------------------------------------------|--------------------|-----|----------------|------|
| All values are referred to V <sub>IH(min)</sub> (0.3 * V <sub>DDL</sub> ) and V <sub>IL(max)</sub> (0.7 * V <sub>DDL</sub> ). See also <a href="#">Figure 20</a> . |                                                  |                                                      |                    |     |                |      |
| f <sub>SCL</sub>                                                                                                                                                   | SCL clock frequency                              |                                                      |                    | —   | 100            | kHz  |
| t <sub>HD;STA</sub>                                                                                                                                                | Hold time (repeated) START condition             | After this period the first clock pulse is generated | 4.0                | —   |                | μs   |
| t <sub>LOW</sub>                                                                                                                                                   | LOW period of the SCL clock                      |                                                      | 4.7                | —   |                | μs   |
| t <sub>HIGH</sub>                                                                                                                                                  | HIGH period of the SCL clock                     |                                                      | 4.0                | —   |                | μs   |
| t <sub>SU;STA</sub>                                                                                                                                                | Set-up time for a repeated START condition       |                                                      | 4.7                | —   |                | μs   |
| t <sub>HD;DAT</sub>                                                                                                                                                | Data hold time <sup>(1)</sup>                    |                                                      | 300 <sup>(2)</sup> | —   | <sup>(3)</sup> | ns   |
| t <sub>SU;DAT</sub>                                                                                                                                                | Data set-up time                                 |                                                      | 250                | —   |                | ns   |
| t <sub>r</sub>                                                                                                                                                     | Rise time of both SDA and SCL signals            |                                                      |                    | —   | 1000           | ns   |
| t <sub>f</sub>                                                                                                                                                     | Fall time of both SDA and SCL signals            |                                                      |                    | —   | 300            | ns   |
| t <sub>SU;STO</sub>                                                                                                                                                | Set-up time for a STOP condition                 |                                                      | 4.0                | —   |                | μs   |
| t <sub>BUF</sub>                                                                                                                                                   | Bus free time between a STOP and START condition |                                                      | 4.7                | —   |                | μs   |

Table 25. I<sup>2</sup>C-bus SDA, SCL bus lines characteristics

| Symbol              | Parameter                                  | Test conditions                                  | Min                    | Typ | Max                 | Unit |
|---------------------|--------------------------------------------|--------------------------------------------------|------------------------|-----|---------------------|------|
| C <sub>b</sub>      | Capacitive load for each bus line          |                                                  |                        | —   | 400                 | pF   |
| t <sub>VD;DAT</sub> | Data valid time <sup>(4)</sup>             |                                                  |                        | —   | 3.45 <sup>(3)</sup> | μs   |
| t <sub>VD;ACK</sub> | Data valid acknowledge time <sup>(5)</sup> |                                                  |                        | —   | 3.45 <sup>(3)</sup> | μs   |
| V <sub>nL</sub>     | Noise margin at the LOW level              | For each connected device (including hysteresis) | 0.1 * V <sub>DDL</sub> | —   |                     | V    |
| V <sub>nH</sub>     | Noise margin at the HIGH level             | For each connected device (including hysteresis) | 0.2 * V <sub>DDL</sub> | —   |                     | V    |

1. t<sub>HD;DAT</sub> is the data hold time that is measured from the falling edge of SCL, applies to data in transmission and the acknowledge.
2. A device must internally provide a hold time of at least 300 ns for the SDA signal (with respect to the V<sub>IH(min)</sub> of the SCL signal) to bridge the undefined region of the falling edge of SCL.
3. The maximum t<sub>HD;DAT</sub> could be 3.45 μs, but must be less than the maximum of t<sub>VD;DAT</sub> or t<sub>VD;ACK</sub> by a transition time.
4. t<sub>VD;DAT</sub> = time for data signal from SCL LOW to SDA output (HIGH or LOW, depending on which one is worse)
5. t<sub>VD;ACK</sub> = time for acknowledgment signal from SCL LOW to SDA output (HIGH or LOW, depending on which one is worse)

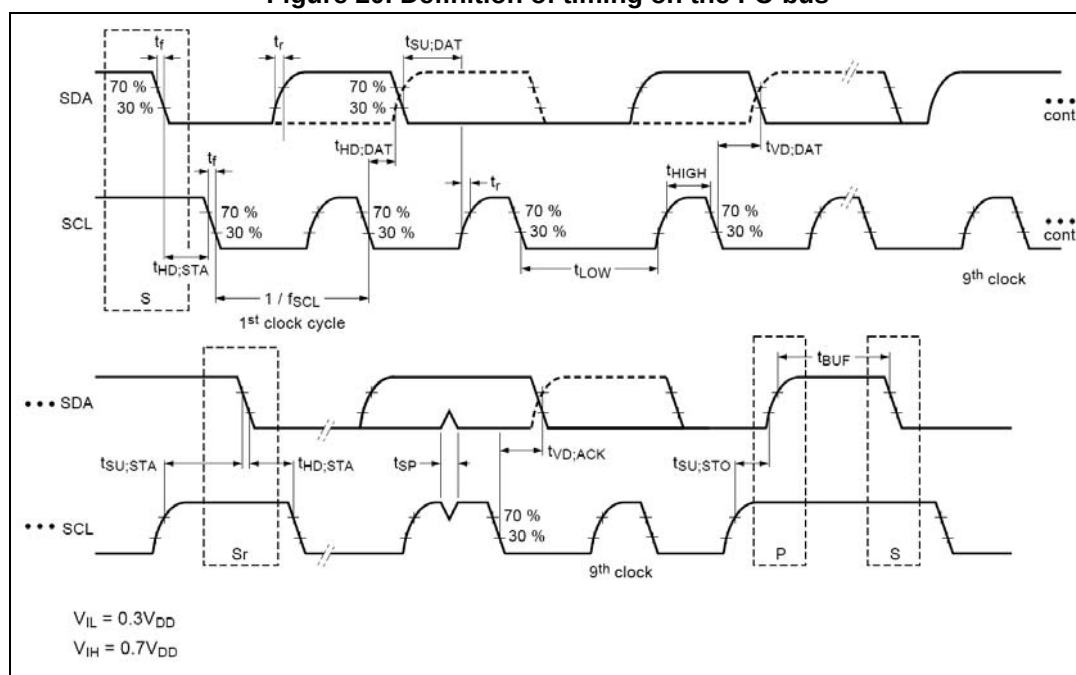
Figure 20. Definition of timing on the I<sup>2</sup>C-bus

Table 26. Electrical transient requirements (part 1)

| ISO 7637-2:<br>2004(E)<br>Test Pulse | Test levels <sup>(1)</sup> |        | Number of<br>pulses or<br>test times | Burst cycle/pulse<br>repetition time |        | Delays and<br>impedance  |
|--------------------------------------|----------------------------|--------|--------------------------------------|--------------------------------------|--------|--------------------------|
|                                      | III                        | IV     |                                      |                                      |        |                          |
| 1                                    | -75 V                      | -100 V | 5000<br>pulses                       | 0.5 s                                | 5 s    | 2 ms, 10 $\Omega$        |
| 2a                                   | +37 V                      | +50 V  | 5000<br>pulses                       | 0.2 s                                | 5 s    | 50 $\mu$ s, 2 $\Omega$   |
| 3a                                   | -100 V                     | -150 V | 1h                                   | 90 ms                                | 100 ms | 0.1 $\mu$ s, 50 $\Omega$ |
| 3b                                   | +75 V                      | +100 V | 1h                                   | 90 ms                                | 100 ms | 0.1 $\mu$ s, 50 $\Omega$ |
| 4                                    | -6 V                       | -7 V   | 1 pulse                              |                                      |        | 100 ms, 0.01 $\Omega$    |
| 5b <sup>(2)</sup>                    | +65 V                      | +87 V  | 1 pulse                              |                                      |        | 400 ms, 2 $\Omega$       |

1. The above test levels must be considered referred to  $V_{CC} = 13.5$  V except for pulse 5b.
2. Valid in case of external load dump clamp: 40V maximum referred to OUT.

Table 27. Electrical transient requirements (part 2)

| ISO 7637-2:<br>2004(E)<br>test pulse | Test level results <sup>(1)</sup> |    |
|--------------------------------------|-----------------------------------|----|
|                                      | III                               | IV |
| 1                                    | C                                 | E  |
| 2a                                   | C                                 | C  |
| 3a                                   | C                                 | C  |
| 3b                                   | C                                 | C  |
| 4                                    | C                                 | C  |
| 5b <sup>(2)</sup>                    | C                                 | C  |

1. The above test levels must be considered referred to  $V_{CC} = 13.5$  V except for pulse 5b.
2. Valid in case of external load dump clamp: 40V maximum referred to OUT.

Table 28. Electrical transient requirements (part 3)

| Class | Contents                                                                                                                                                         |
|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| C     | All functions of the device are performed as designed after exposure to disturbance.                                                                             |
| E     | One or more functions of the device are not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the |

7      **OTP (One Time Programmable Memory)**

L99SD01-E provides two 16 bit OTP modules for internal parameter trimming. Default application parameters are hard coded into the device. OTP use is reserved to ST and other access will be hardware forbidden.

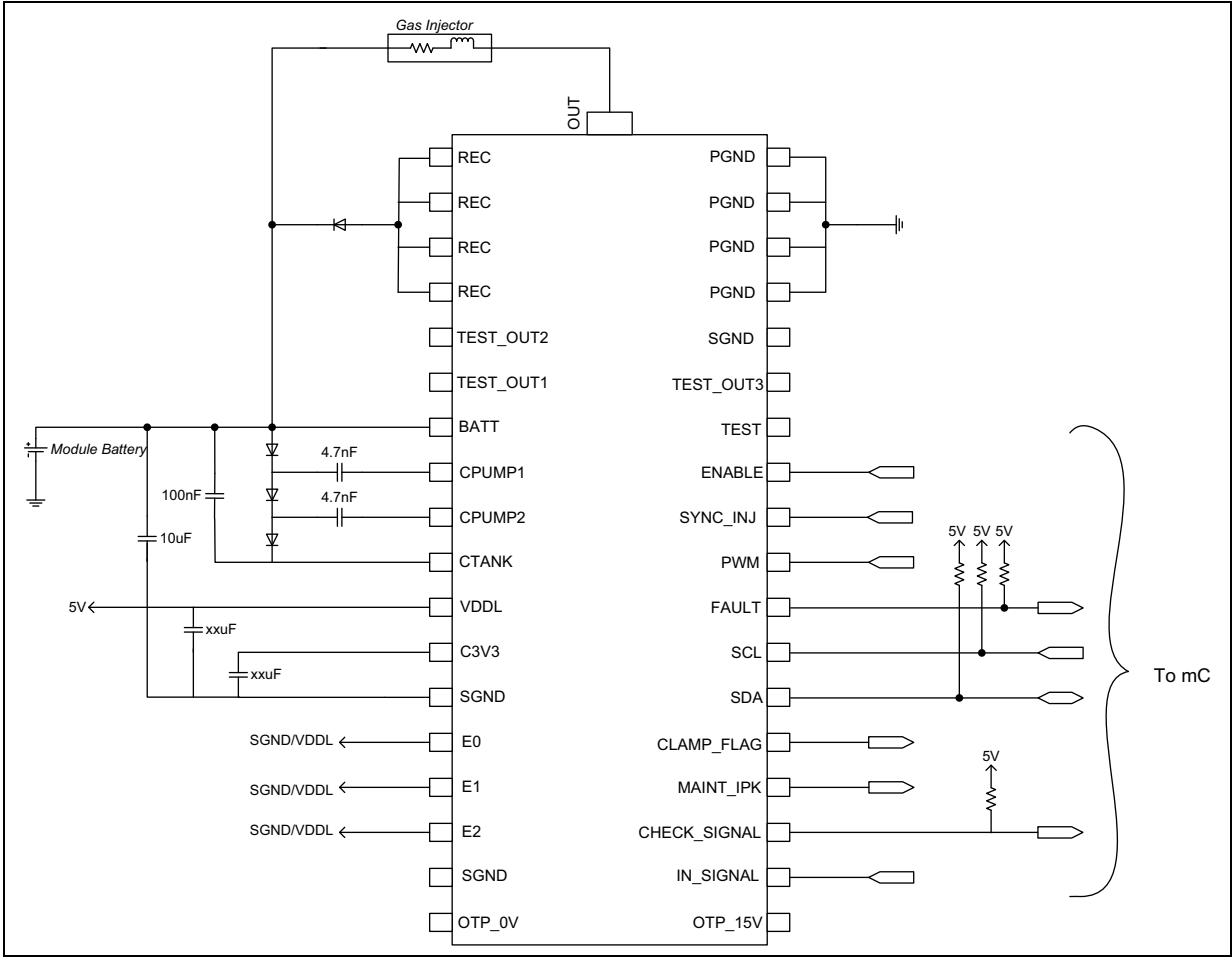
**Table 29. 16 bit OTP modules**

|       | Bit<br>15 | Bit<br>14 | Bit<br>13 | Bit<br>12       | Bit<br>11 | Bit<br>10 | Bit<br>9                   | Bit<br>8 | Bit<br>7 | Bit<br>6 | Bit<br>5 | Bit<br>4               | Bit<br>3 | Bit<br>2 | Bit<br>1 | Bit<br>0 |
|-------|-----------|-----------|-----------|-----------------|-----------|-----------|----------------------------|----------|----------|----------|----------|------------------------|----------|----------|----------|----------|
| OTP_0 |           |           |           | Osc trimming    |           |           | Current reference trimming |          |          |          |          | Bandgap trimming       |          |          |          |          |
| OTP_1 |           |           |           | Reference slope |           |           |                            |          | Blanking |          |          | IHOLD current trimming |          |          |          |          |



# 8 Application schematic

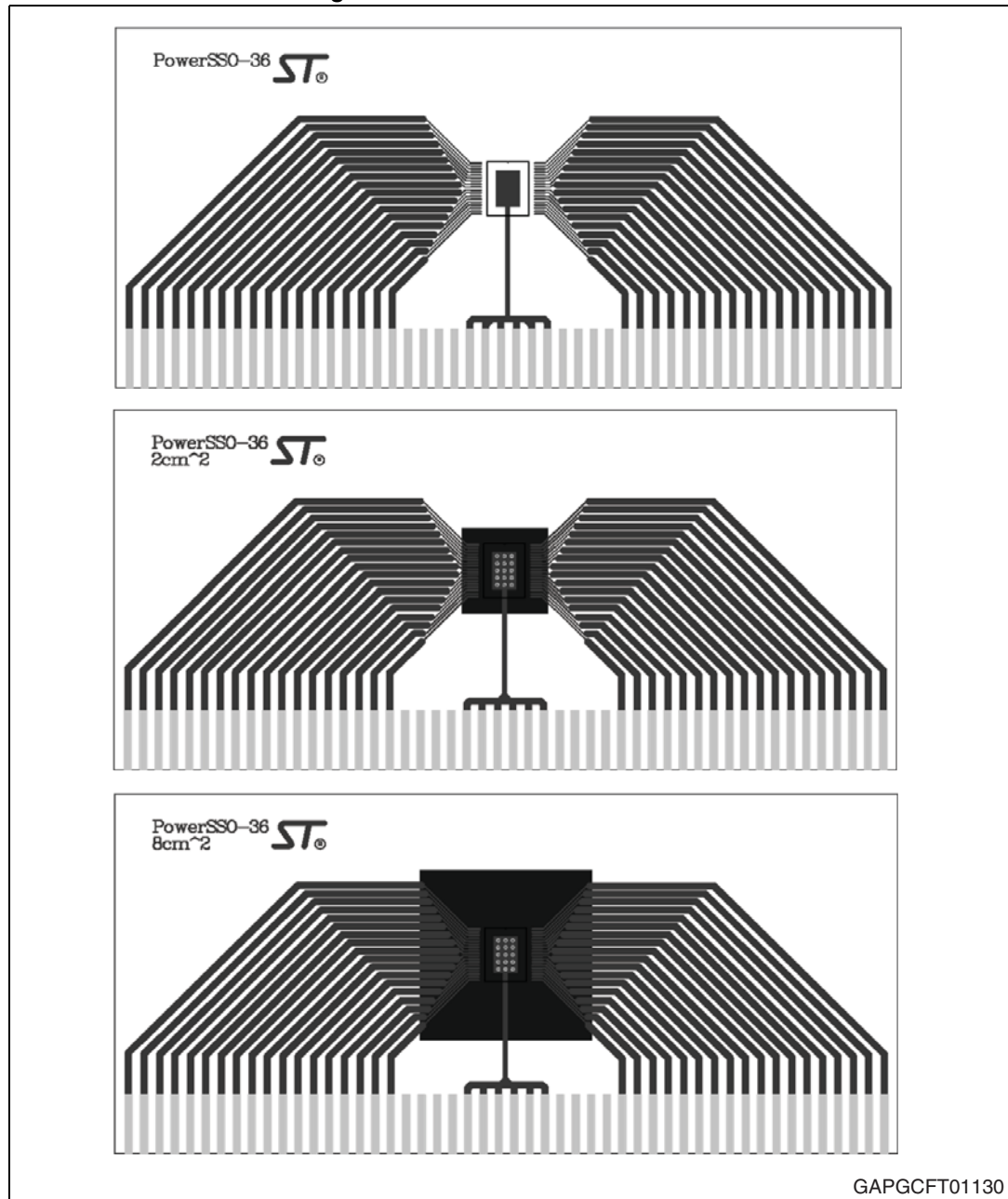
Figure 21. Application schematic



## 9 Package and PCB thermal data

### 9.1 PowerSSO-36 thermal data

Figure 22. PowerSSO-36 PC board



1. Board finish thickness 1.6 mm +/- 10%; Board double layer; Board dimension 129 mm x 60 mm; Board Material FR4; Cu thickness 0.070 mm; Thermal vias separation 1.2 mm; Thermal via diameter 0.3 mm +/- 0.08 mm; Cu thickness on vias 0.025 mm; Footprint dimension 4.1 mm x 6.5 mm.

Figure 23. Rthj-amb vs PCB copper area in open box free air condition

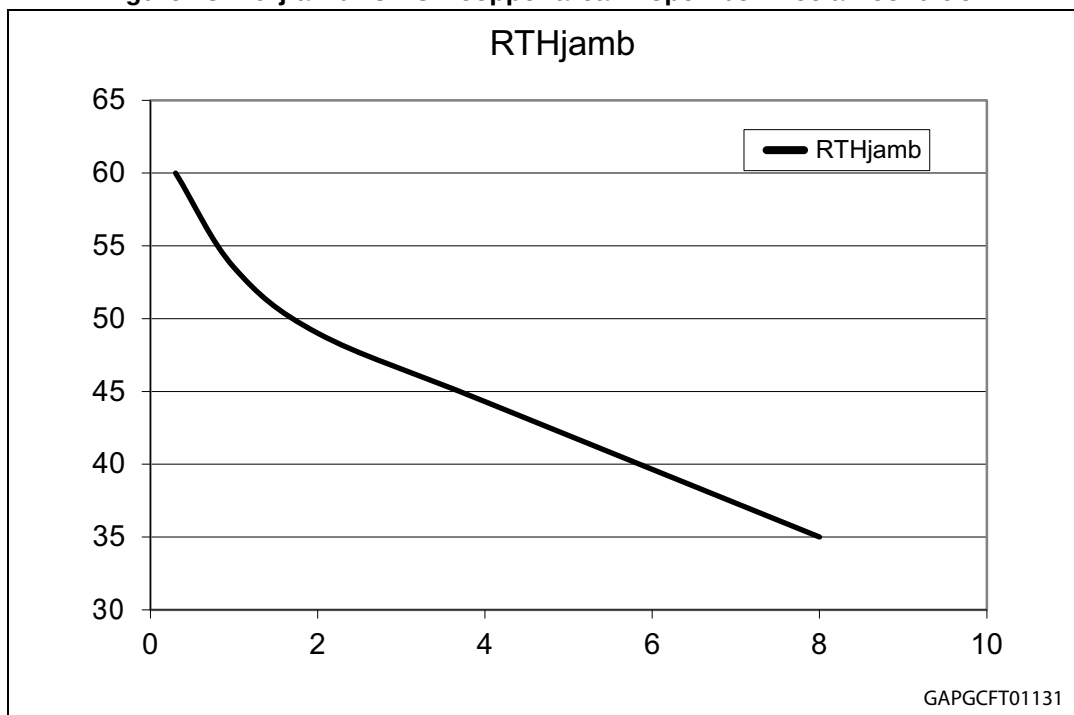


Figure 24. PowerSSO-36 thermal impedance junction ambient

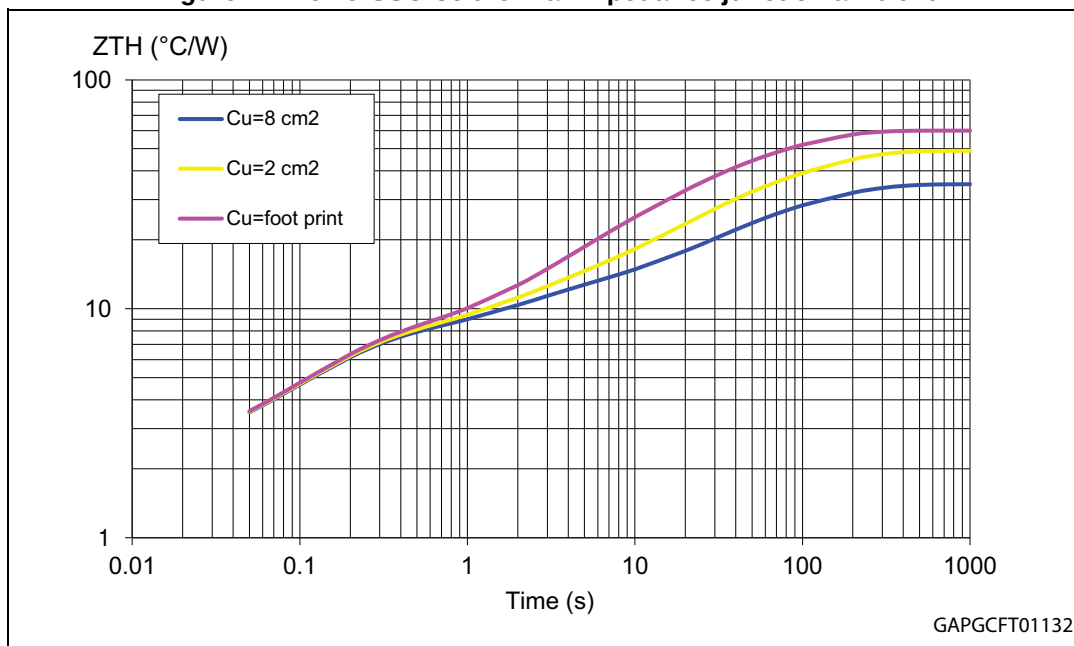


Figure 25. Thermal fitting model of a HSD in PowerSSO-36

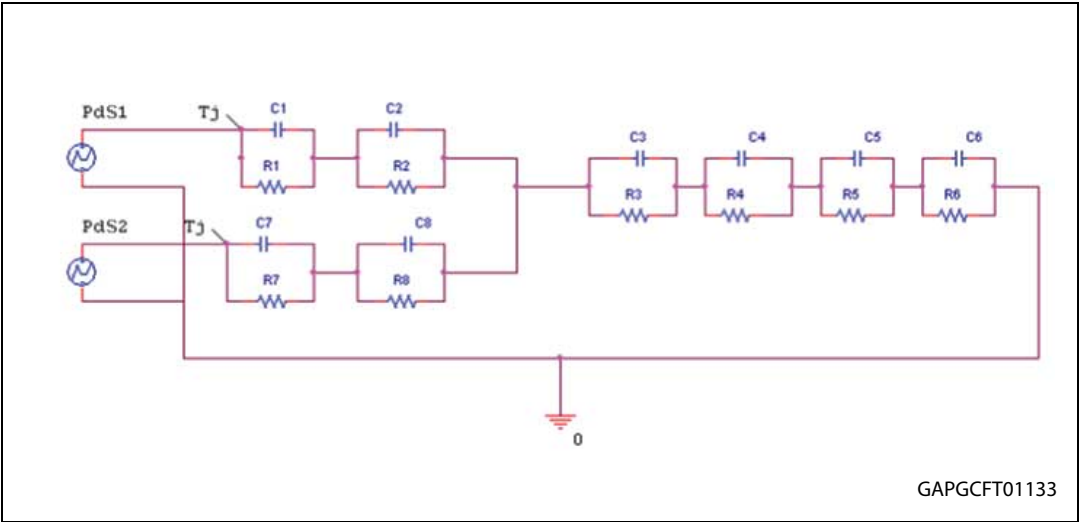


Table 30. Thermal parameters

| Area/island (cm <sup>2</sup> ) | FP     | 2   | 8  |
|--------------------------------|--------|-----|----|
| R1 = R7 (°C/W)                 | 0.8    |     |    |
| R2 = R8 (°C/W)                 | 1.2    |     |    |
| R3 (°C/W)                      | 5      |     |    |
| R4 (°C/W)                      | 8      |     |    |
| R5 (°C/W)                      | 18     | 15  | 10 |
| R6 (°C/W)                      | 27     | 23  | 14 |
| C1 = C7 (W·s/°C)               | 0.0005 |     |    |
| C2 = C8 (W·s/°C)               | 0.002  |     |    |
| C3 (W·s/°C)                    | 0.03   |     |    |
| C4 (W·s/°C)                    | 0.5    |     |    |
| C5 (W·s/°C)                    | 1      | 1.5 | 3  |
| C6 (W·s/°C)                    | 3      | 5   | 9  |

## 10 Package and packing Information

### 10.1 ECOPACK<sup>®</sup> packages

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).

ECOPACK<sup>®</sup> is an ST trademark.

### 10.2 PowerSSO-36 package information

Figure 26. PowerSSO-36 package dimensions

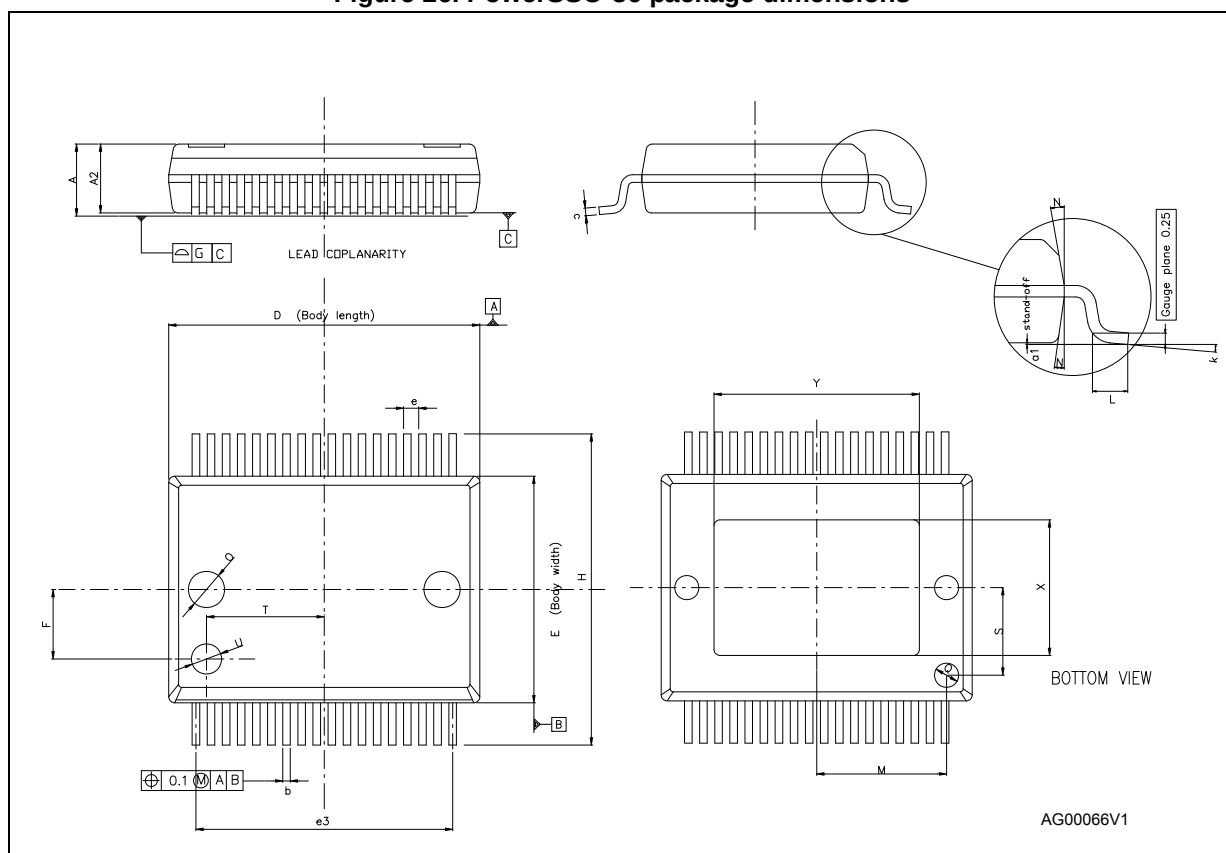


Table 31. PowerSSO-36 mechanical data

| Symbol | Millimeters |      |      |
|--------|-------------|------|------|
|        | Min         | Typ. | Max  |
| A      | 2.15        |      | 2.47 |
| A2     | 2.15        |      | 2.40 |
| a1     | 0           |      | 0.1  |
| b      | 0.18        |      | 0.36 |

Table 31. PowerSSO-36 mechanical data

| Symbol           | Millimeters |      |       |
|------------------|-------------|------|-------|
|                  | Min         | Typ. | Max   |
| c                | 0.23        |      | 0.32  |
| D <sup>(1)</sup> | 10.10       |      | 10.50 |
| E                | 7.4         |      | 7.6   |
| e                |             | 0.5  |       |
| e3               |             | 8.5  |       |
| F                |             | 2.3  |       |
| G                |             |      | 0.1   |
| G1               |             |      | 0.06  |
| H                | 10.1        |      | 10.5  |
| h                |             |      | 0.4   |
| k                | 0°          |      | 8°    |
| L                | 0.55        |      | 0.90  |
| M                |             | 4.3  |       |
| N                |             |      | 10°   |
| O                |             | 1.2  |       |
| Q                |             | 0.8  |       |
| S                |             | 2.9  |       |
| T                |             | 3.65 |       |
| U                |             | 1    |       |
| X                | 4.1         |      | 4.7   |
| Y                | 6.5         |      | 7.1   |

1. "D" and "E" do not include mold Flash or protrusions. Mold Flash or protrusion shall not exceed 0.15 mm per side (0.006").

# 11 Revision history

Table 32. Document revision history

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
|-------------|----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 05-Dec-2011 | 1        | Initial release                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| 12-Sep-2013 | 2        | <p><a href="#">Table 2: Pin description</a>:</p> <ul style="list-style-type: none"> <li>– SCL: updated description</li> </ul> <p>Updated <a href="#">Section 4.1: SDA and SCL signals</a></p> <p>Added <a href="#">Chapter 5: Register description</a></p> <p><a href="#">Table 5: Absolute maximum rating</a>:</p> <ul style="list-style-type: none"> <li>– <math>I_{LOAD}</math>, <math>I_{R(Load)}</math>: updated value</li> <li>– EC: deleted rows</li> <li>– <math>E_{AS}</math>, <math>E_{REP1}</math>, <math>E_{REP2}</math>: added rows</li> </ul> <p>Updated <a href="#">Table 6: Thermal data</a></p> <p><a href="#">Table 18: Current sense comparator</a>:</p> <ul style="list-style-type: none"> <li>– <math>V_{IOFF\_PWMCOMP}</math>: updated min value</li> </ul> <p><a href="#">Table 20: S1 protections and diagnostic</a>:</p> <ul style="list-style-type: none"> <li>– <math>I_{OL}</math>: added test condition and values</li> </ul> <p><a href="#">Table 22: IPEAK, IHOLD (<math>-40\text{ }^{\circ}\text{C} &lt; T_j &lt; 150\text{ }^{\circ}\text{C}</math>, unless otherwise specified)</a>:</p> <ul style="list-style-type: none"> <li>– <math>I_{PEAK}</math>, <math>I_{HOLD}</math>: added test condition and values</li> </ul> <p><a href="#">Table 23: Charge pump</a>:</p> <ul style="list-style-type: none"> <li>– added note</li> <li>– <math>I_{CP1}</math>, <math>I_{CP2}</math>: added rows</li> </ul> <p><a href="#">Table 24: I2C-bus SDA, SCL I/O stages</a>:</p> <ul style="list-style-type: none"> <li>– <math>I_{OL}</math>: removed test condition</li> <li>– <math>t_{OFF}</math>: updated parameter, removed test condition and min value</li> </ul> <p><a href="#">Table 25: I2C-bus SDA, SCL bus lines characteristics</a>:</p> <ul style="list-style-type: none"> <li>– <math>f_{SCL}</math>, <math>t_{HD;STA}</math>, <math>t_{LOW}</math>, <math>t_{HIGH}</math>, <math>t_{SU;STA}</math>, <math>t_{HD;DAT}</math>, <math>t_{SU;DAT}</math>, <math>t_r</math>, <math>t_f</math>, <math>t_{SU;STO}</math>, <math>t_{BUF}</math>, <math>C_b</math>, <math>t_{VD;DAT}</math>, <math>t_{VD;ACK}</math>: updated values</li> </ul> <p>Added <a href="#">Table 26: Electrical transient requirements (part 1)</a>,<br/> <a href="#">Table 27: Electrical transient requirements (part 2)</a> and<br/> <a href="#">Table 28: Electrical transient requirements (part 3)</a></p> <p>Added <a href="#">Chapter 9: Package and PCB thermal data</a></p> |
| 18-Sep-2013 | 3        | Updated disclaimer.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| 11-Apr-2014 | 4        | Updated document title.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| 18-Dec-2014 | 5        | Updated document title, <a href="#">Features</a> and <a href="#">Description</a> .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |

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